

CC1311P3 SimpleLink™ High-Performance Sub-1GHz Wireless MCU with Integrated Power Amplifier

1 Features

Wireless microcontroller

- Powerful 48MHz Arm® Cortex®-M4 processor
- 352KB flash program memory
- 32KB of ultra-low leakage SRAM
- 8KB of Cache SRAM (Alternatively available as general-purpose RAM)
- Programmable radio includes support for 2-(G)FSK, 4-(G)FSK, MSK, OOK, IEEE 802.15.4 PHY and MAC
- Supports over-the-air upgrade (OTA)

Low power consumption

- MCU consumption:
 - 2.63mA active mode, CoreMark®
 - 55µA/MHz running CoreMark
 - 0.7µA standby mode, RTC, 32KB RAM
 - 0.1µA shutdown mode, wake-up on pin
- Radio Consumption:
 - 5.4mA RX at 868MHz
 - 24.9mA TX at +14dBm at 868MHz
 - 65mA TX at +20dBm at 915MHz

Wireless protocol support

- [Mioty](#)
- [Wireless M-Bus](#)
- [SimpleLink™ TI 15.4-stack](#)
- 6LoWPAN
- [Proprietary systems](#)

High-performance radio

- -121dBm for 2.5kbps long-range mode
- -120dBm at 4.8kbps narrowband mode, 433MHz
- -118dBm at 9.6kbps narrowband mode, 868MHz
- -110dBm at 50kbps, 802.15.4, 868MHz
- Output power up to +20dBm with temperature compensation
- Down to 4kHz receiver filter bandwidth

Regulatory compliance

- Designed for systems targeting compliance with these standards:
 - ETSI EN 300 220 Receiver Cat. 1.5 and 2, EN 303 131, EN 303 204
 - FCC CFR47 Part 15
 - ARIB STD-T108

MCU peripherals

- Digital peripherals can be routed to any GPIO
- Four 32-bit or eight 16-bit general-purpose timers
- 12-bit ADC, 200 kSamples/s, 8 channels
- 8-bit DAC
- Analog Comparator
- UART, SSI, I²C, I²S
- Real-time clock (RTC)
- Integrated temperature and battery monitor

Security enablers

- AES 128-bit cryptographic accelerator
- True random number generator (TRNG)
- Additional cryptography drivers available in Software Development Kit (SDK)

Development tools and software

- [LP-CC1311P3 Development Kit](#)
- [SimpleLink™ CC13xx and CC26xx Software Development Kit \(SDK\)](#)
- [SmartRF™ Studio](#) for simple radio configuration
- [SysConfig](#) system configuration tool

Operating range

- On-chip buck DC/DC converter
- 1.8V to 3.8V single supply voltage
- -40 to +105°C

Package

- 7mm × 7mm RGZ VQFN48 (26 GPIOs)
- RoHS-compliant package



2 Applications

- **Grid infrastructure**
 - Smart Meters—[electricity meter](#), [water meter](#), [gas meter](#), and [heat cost allocator](#)
 - Grid communications—[wireless communications](#)
 - EV charging infrastructure—[AC charging \(pile\) station](#)
 - Other alternative energy—[energy harvesting](#)
- **Building automation**
 - Building security systems—[motion detector](#), [door and window sensor](#), [glass break detector](#), [panic button](#), [electronic smart lock](#), and [IP network camera](#)
 - HVAC systems—[thermostat](#), [environmental sensor](#), and [HVAC controller](#)
- Fire safety—[smoke and head detector](#), [gas detector](#), and [fire alarm control panel](#)
- **Retail Automation**
 - Retail automation and payment applications—[electronic shelf labels](#) and [portable POS terminal](#)
- **Personal Electronics**
 - [RF remote controls](#)
 - [Smart Speakers](#) and [smart displays](#)
 - [Gaming](#) and [electronic and robotic toys](#)
 - [Wearables \(non-medical\)](#) and [smart trackers](#)
- **Wireless Modules**
 - [Wireless third-party modules](#)
 - [Wireless communications modules](#)

3 Description

The SimpleLink™ CC1311P3 device is a multiprotocol Sub-1GHz wireless microcontroller (MCU) supporting IEEE 802.15.4g, IPv6-enabled smart objects (6LoWPAN), [mioty](#), proprietary systems, including the [TI 15.4-Stack](#) (Sub-1GHz). The CC1311P3 is based on an Arm® Cortex® M4 main processor and optimized for low-power wireless communication and advanced sensing in [grid infrastructure](#), [building automation](#), [retail automation](#), [personal electronics](#), and [medical applications](#).

The CC1311P3 has a software-defined radio powered by an Arm® Cortex® M0, which allows support for multiple physical layers and RF standards. The device supports operation in 143MHz to 176MHz, 287MHz to 351MHz, 359MHz to 527-MHz, 861MHz to 1054MHz, and 1076MHz to 1315MHz frequency bands. The CC1311P3 has an efficient built-in PA that supports +14dBm TX at 24.9mA and +20dBm TX at 65mA. In RX, it has -121dBm sensitivity and 88dB blocking ± 10 MHz in SimpleLink™ long-range mode with 2.5kbps data rate.

The CC1311P3 has a low sleep current of 0.7 μ A with RTC and 32KB RAM retention.

Consistent with many customers' 10 to 15 years or longer life cycle requirements, TI has a [product life cycle policy](#) with a commitment to product longevity and continuity of supply.

The CC1311P3 device is part of the SimpleLink™ MCU platform, which consists of Wi-Fi®, [Bluetooth®](#) Low Energy, Thread, Zigbee, Wi-SUN®, Amazon Sidewalk, [mioty](#), Sub-1GHz MCUs, and host MCUs. CC1311P3 is part of a scalable portfolio with flash sizes from 32KB to 704KB with pin-to-pin compatible package options. The common [SimpleLink™ CC13xx and CC26xx Software Development Kit \(SDK\)](#) and [SysConfig](#) system configuration tool support migration between devices in the portfolio. A comprehensive number of software stacks, application examples, and SimpleLink™ Academy training sessions are included in the SDK. For more information, visit [wireless connectivity](#).

Device Information

PART NUMBER ⁽¹⁾	PACKAGE	PACKAGE SIZE
CC1311P31T0RGZR	VQFN (48)	7.00mm × 7.00mm

(1) For more information, see [Section 12](#).

4 Functional Block Diagram

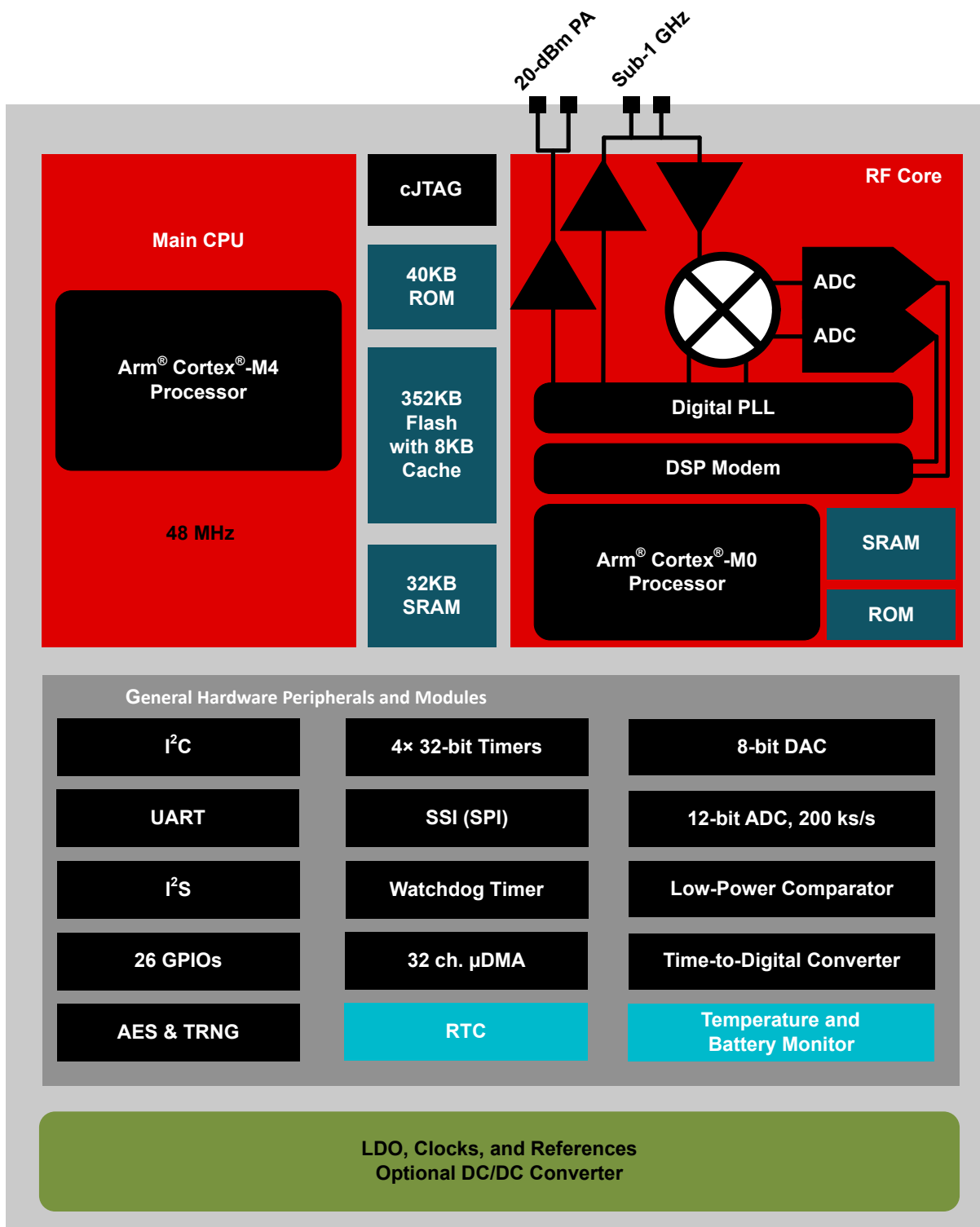


Figure 4-1. CC1311P3 Functional Block Diagram

Table of Contents

1 Features	1	7.19 Typical Characteristics.....	30
2 Applications	2	8 Detailed Description	37
3 Description	2	8.1 Overview.....	37
4 Functional Block Diagram	3	8.2 System CPU.....	37
5 Device Comparison	5	8.3 Radio (RF Core).....	38
6 Pin Configuration and Functions	6	8.4 Memory.....	40
6.1 Pin Diagram—RGZ Package (Top View).....	6	8.5 Cryptography.....	41
6.2 Signal Descriptions—RGZ Package.....	7	8.6 Timers.....	42
6.3 Connections for Unused Pins and Modules.....	8	8.7 Serial Peripherals and I/O.....	43
7 Specifications	9	8.8 Battery and Temperature Monitor.....	43
7.1 Absolute Maximum Ratings.....	9	8.9 Voltage Supply Domains.....	43
7.2 ESD Ratings.....	9	8.10 μ DMA.....	43
7.3 Recommended Operating Conditions.....	9	8.11 Debug.....	44
7.4 Power Supply and Modules.....	10	8.12 Power Management.....	45
7.5 Power Consumption - Power Modes.....	10	8.13 Clock Systems.....	46
7.6 Power Consumption - Radio Modes.....	11	8.14 Network Processor.....	46
7.7 Nonvolatile (Flash) Memory Characteristics.....	11	9 Application, Implementation, and Layout	47
7.8 Thermal Resistance Characteristics.....	11	9.1 Reference Designs.....	47
7.9 RF Frequency Bands.....	12	10 Device and Documentation Support	48
7.10 861MHz to 1054MHz—Receive (RX).....	12	10.1 Device Nomenclature.....	48
7.11 861 MHz to 1054 MHz - Transmit (TX)	15	10.2 Tools and Software.....	49
7.12 861 MHz to 1054 MHz - PLL Phase Noise		10.3 Documentation Support.....	51
Wideband Mode.....	16	10.4 Support Resources.....	51
7.13 861 MHz to 1054 MHz - PLL Phase Noise		10.5 Trademarks.....	51
Narrowband Mode.....	17	10.6 Electrostatic Discharge Caution.....	52
7.14 359MHz to 527MHz—Receive (RX).....	17	10.7 Glossary.....	52
7.15 359 MHz to 527 MHz - Transmit (TX)	19	11 Revision History	52
7.16 359 MHz to 527 MHz - PLL Phase Noise.....	19	12 Mechanical, Packaging, and Orderable	
7.17 Timing and Switching Characteristics.....	20	Information	53
7.18 Peripheral Characteristics.....	24		

5 Device Comparison

DEVICE	RADIO SUPPORT											FLASH (kB)	RAM + CACHE (kB)	GPIO	PACKAGE SIZE					
	Sub-1GHz Prop.	2.4GHz Prop.	Wireless M-Bus	mioty	Wi-SUN®	Sidewalk	Bluetooth® LE	Zigbee	Thread	Multiprotocol	+20dBm PA				4 × 4mm VQFN (24)	4 × 4mm VQFN (32)	5 × 5mm VQFN (32)	5 × 5mm VQFN (40)	7 × 7mm VQFN (48)	8 × 8mm VQFN (64)
CC1310	√		√	√								32-128	16-20 + 8	10–30		√	√		√	
CC1311R3	√		√	√								352	32 + 8	22–30				√	√	
CC1311P3	√		√	√							√	352	32 + 8	26					√	
CC1312R	√		√	√	√							352	80 + 8	30					√	
CC1312R7	√		√	√	√	√				√		704	144 + 8	30					√	
CC1314R10	√		√	√	√	√				√		1024	256 + 8	30-46					√	√
CC1352R	√	√	√	√	√		√	√	√	√		352	80 + 8	28					√	
CC1354R10	√	√	√	√	√		√	√	√	√		1024	256 + 8	28-42					√	√
CC1352P	√	√	√	√	√		√	√	√	√	√	352	80 + 8	26					√	
CC1352P7	√	√	√	√	√	√	√	√	√	√	√	704	144 + 8	26					√	
CC1354P10	√	√	√	√	√	√	√	√	√	√	√	1024	256 + 8	26–42					√	√
CC2340R2		√					√	√				256	28	12	√					
CC2340R5 ⁽¹⁾		√					√	√	√			512	36	12–26	√			√		
CC2340R5-Q1							√					512	36	19			√			
CC2640R2F							√					128	20 + 8	10–31		√	√		√	
CC2642R							√					352	80 + 8	31					√	
CC2642R-Q1							√					352	80 + 8	31					√	
CC2651R3		√					√	√				352	32 + 8	23–31				√	√	
CC2651P3		√					√	√			√	352	32 + 8	22–26				√	√	
CC2652R		√					√	√	√	√		352	80 + 8	31					√	
CC2652RB		√					√	√	√	√		352	80 + 8	31					√	
CC2652R7		√					√	√	√	√		704	144 + 8	31					√	
CC2652P		√					√	√	√	√	√	352	80 + 8	26					√	
CC2652P7		√					√	√	√	√	√	704	144 + 8	26					√	
CC2674R10		√					√	√	√	√		1024	256 + 8	31–45					√	√
CC2674P10		√					√	√	√	√	√	1024	256 + 8	26–45					√	√

(1) Thread support enabled by a future software update

6 Pin Configuration and Functions

6.1 Pin Diagram—RGZ Package (Top View)

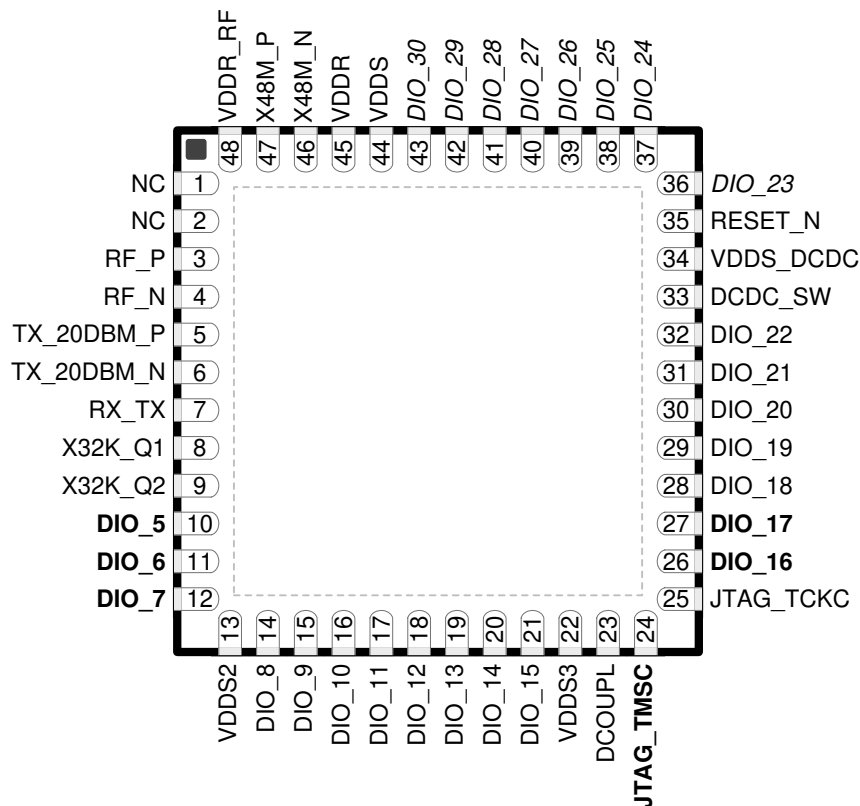


Figure 6-1. RGZ (7mm × 7mm) Pinout, 0.5mm Pitch (Top View)

The following I/O pins marked in [Figure 6-1](#) in **bold** have high-drive capabilities:

- Pin 10, **DIO_5**
- Pin 11, **DIO_6**
- Pin 12, **DIO_7**
- Pin 24, JTAG_TMISC
- Pin 26, **DIO_16**
- Pin 27, **DIO_17**

The following I/O pins marked in [Figure 6-1](#) in *italics* have analog capabilities:

- Pin 36, *DIO_23*
- Pin 37, *DIO_24*
- Pin 38, *DIO_25*
- Pin 39, *DIO_26*
- Pin 40, *DIO_27*
- Pin 41, *DIO_28*
- Pin 42, *DIO_29*
- Pin 43, *DIO_30*

6.2 Signal Descriptions—RGZ Package

Table 6-1. Signal Descriptions—RGZ Package

PIN		I/O	TYPE	DESCRIPTION
NAME	NO.			
DCDC_SW	33	—	Power	Output from internal DC/DC converter ⁽¹⁾
DCOUPPL	23	—	Power	For decoupling of internal 1.27V regulated digital-supply ⁽²⁾
DIO_5	10	I/O	Digital	GPIO, high-drive capability
DIO_6	11	I/O	Digital	GPIO, high-drive capability
DIO_7	12	I/O	Digital	GPIO, high-drive capability
DIO_8	14	I/O	Digital	GPIO
DIO_9	15	I/O	Digital	GPIO
DIO_10	16	I/O	Digital	GPIO
DIO_11	17	I/O	Digital	GPIO
DIO_12	18	I/O	Digital	GPIO
DIO_13	19	I/O	Digital	GPIO
DIO_14	20	I/O	Digital	GPIO
DIO_15	21	I/O	Digital	GPIO
DIO_16	26	I/O	Digital	GPIO, JTAG_TDO, high-drive capability
DIO_17	27	I/O	Digital	GPIO, JTAG_TDI, high-drive capability
DIO_18	28	I/O	Digital	GPIO
DIO_19	29	I/O	Digital	GPIO
DIO_20	30	I/O	Digital	GPIO
DIO_21	31	I/O	Digital	GPIO
DIO_22	32	I/O	Digital	GPIO
DIO_23	36	I/O	Digital or Analog	GPIO, analog capability
DIO_24	37	I/O	Digital or Analog	GPIO, analog capability
DIO_25	38	I/O	Digital or Analog	GPIO, analog capability
DIO_26	39	I/O	Digital or Analog	GPIO, analog capability
DIO_27	40	I/O	Digital or Analog	GPIO, analog capability
DIO_28	41	I/O	Digital or Analog	GPIO, analog capability
DIO_29	42	I/O	Digital or Analog	GPIO, analog capability
DIO_30	43	I/O	Digital or Analog	GPIO, analog capability
EGP	—	—	GND	Ground – exposed ground pad ⁽³⁾
JTAG_TMSC	24	I/O	Digital	JTAG TMS, high-drive capability
JTAG_TCKC	25	I	Digital	JTAG TCK
RESET_N	35	I	Digital	Reset, active low. No internal pullup resistor
RF_P	3	—	RF	Positive RF input signal to LNA during RX Positive RF output signal from PA during TX
RF_N	4	—	RF	Negative RF input signal to LNA during RX Negative RF output signal from PA during TX
RX_TX	7	—	RF	Optional bias pin for the RF LNA
TX_20DBM_P	5	—	RF	Positive high-power TX signal
TX_20DBM_N	6	—	RF	Negative high-power TX signal
VDDR	45	—	Power	Internal supply, must be powered from the internal DC/DC converter or the internal LDO ^{(2) (4) (6)}
VDDR_RF	48	—	Power	Internal supply, must be powered from the internal DC/DC converter or the internal LDO ^{(2) (5) (6)}
VDDS	44	—	Power	1.8V to 3.8V main chip supply ⁽¹⁾

Table 6-1. Signal Descriptions—RGZ Package (continued)

PIN		I/O	TYPE	DESCRIPTION
NAME	NO.			
VDDS2	13	—	Power	1.8V to 3.8V DIO supply ⁽¹⁾
VDDS3	22	—	Power	1.8V to 3.8V DIO supply ⁽¹⁾
VDDS_DCDC	34	—	Power	1.8V to 3.8V DC/DC converter supply
X48M_N	46	—	Analog	48-MHz crystal oscillator pin 1
X48M_P	47	—	Analog	48-MHz crystal oscillator pin 2
X32K_Q1	8	—	Analog	32kHz crystal oscillator pin 1
X32K_Q2	9	—	Analog	32kHz crystal oscillator pin 2

- (1) For more details, see the device technical reference manual listed in [Section 10.3](#).
 (2) Do not supply external circuitry from this pin.
 (3) EGP is the only ground connection for the device. Good electrical connection to device ground on printed circuit board (PCB) is imperative for proper device operation.
 (4) If the internal DC/DC converter is not used, this pin is supplied internally from the main LDO.
 (5) If the internal DC/DC converter is not used, this pin must be connected to VDDR for supply from the main LDO.
 (6) The output from the internal DC/DC and LDO is trimmed to 1.68V.

6.3 Connections for Unused Pins and Modules

Table 6-2. Connections for Unused Pins—RGZ Package

FUNCTION	SIGNAL NAME	PIN NUMBER	ACCEPTABLE PRACTICE ⁽¹⁾	PREFERRED PRACTICE ⁽¹⁾
GPIO	DIO_n	10–12 14–21 26–32 36–43	NC or GND	NC
32.768kHz crystal	X32K_Q1	8	NC or GND	NC
	X32K_Q2	9		
No Connects	NC	1–2	NC	NC
DC/DC converter ⁽²⁾	DCDC_SW	33	NC	NC
	VDDS_DCDC	34	VDDS	VDDS

- (1) NC = No connect
 (2) When the DC/DC converter is not used, the inductor between DCDC_SW and VDDR can be removed. VDDR and VDDR_RF must still be connected and the 22µF DCDC capacitor must be kept on the VDDR net.

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)^{(1) (2)}

		MIN	MAX	UNIT
V _{DDS}	Supply voltage	−0.3	4.1	V
	Voltage on any digital pin ^{(3) (4) (5)}	−0.3	V _{DDSn} + 0.3, max 4.1	V
	Voltage on crystal oscillator pins, X32K_Q1, X32K_Q2, X48M_N and X48M_P	−0.3	V _{DDR} + 0.3, max 2.25	V
V _{in}	Voltage on ADC input	Voltage scaling enabled	V _{DDS}	V
		Voltage scaling disabled, internal reference	1.49	
		Voltage scaling disabled, V _{DDS} as reference	V _{DDS} / 2.9	
	Input level, RF pins (RF_P and RF_N)		10	dBm
T _{stg}	Storage temperature	−40	150	°C

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, and performance, and shorten the device's lifetime.
- (2) All voltage values are with respect to ground, unless otherwise noted.
- (3) Including analog capable DIOs
- (4) Injection current is not supported on any GPIO pin.
- (5) V_{DDS2} and V_{DDS3} must be lower or equal to V_{DDS}.

7.2 ESD Ratings

				VALUE	UNIT
V _{ESD}	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS001 ⁽¹⁾	All pins	±2000	V
		Charged device model (CDM), per JESD22-C101 ⁽²⁾	All pins	±500	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
Operating ambient temperature ^{(1) (2)}		−40	105	°C
Operating junction temperature ^{(1) (2)}		−40	115	°C
Operating supply voltage (V _{DDS})		1.8	3.8	V
Operating supply voltage (V _{DDS2} and V _{DDS3}) ^{(4) (5) (6)}		1.8	V _{DDS}	
Operating supply voltage (V _{DDS}), boost mode	V _{DDR} = 1.95 V +14dBm RF output sub-1 GHz power amplifier	2.1	3.8	V
Operating supply voltage (V _{DDS2} and V _{DDS3}), boost mode ⁽⁴⁾	V _{DDR} = 1.95V +14 dBm RF output Sub-1GHz power amplifier	1.8	V _{DDS}	V
Rising supply voltage slew rate		0	100	mV/μs
Falling supply voltage slew rate ⁽³⁾		0	20	mV/μs

- (1) Operation at or near maximum operating temperature for extended durations will result in lifetime reduction.
- (2) See the Thermal Resistance Characteristics section for more information.
- (3) For small coin-cell batteries, with high worst-case end-of-life equivalent source resistance, a 22-μF V_{DDS} input capacitor must be used to ensure compliance with this slew rate.
- (4) V_{DDS2} and V_{DDS3} must be lower or equal to V_{DDS}. For JTAG operation V_{DDS} should be equal to V_{DDS3}
- (5) All power segments need to be powered all times
- (6) If the IO strength is set to auto, the drive strength is adjusted based on the voltage level for V_{DDS}. In the case of V_{DDS2} is lower than V_{DDS}, all pins referred to V_{DDS2} should be manually set (IOCFGn.IOSTR), for example to maximum. In the case of V_{DDS3} is lower than V_{DDS}, all pins referred to V_{DDS3} should be manually set (IOCFGn.IOSTR), for example to maximum.

7.4 Power Supply and Modules

over operating free-air temperature range (unless otherwise noted)

PARAMETER		MIN	TYP	MAX	UNIT
VDDS Power-on-Reset (POR) threshold		1.1	1.55		V
VDDS Brown-out Detector (BOD) ⁽¹⁾	Rising threshold		1.77		V
VDDS Brown-out Detector (BOD), before initial boot ⁽²⁾	Rising threshold		1.70		V
VDDS Brown-out Detector (BOD) ⁽¹⁾	Falling threshold		1.75		V

(1) For boost mode (VDDR = 1.95 V), TI drivers software initialization will trim VDDS BOD limits to maximum (approximately 2.0 V)

(2) Brown-out Detector is trimmed at initial boot, value is kept until device is reset by a POR reset or the RESET_N pin

7.5 Power Consumption - Power Modes

When measured on the CC1311-P3EM-7XD7793-PA915 reference design with $T_c = 25^\circ\text{C}$, $V_{\text{DDS}} = 3.6\text{ V}$ ($V_{\text{DDS}}=V_{\text{DDS2}}=V_{\text{DDS3}}$) with DC/DC enabled unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Core Current Consumption					
I_{core}	Reset and Shutdown	Reset. RESET_N pin asserted or VDDS below power-on-reset threshold	115		nA
		Shutdown. No clocks running, no retention	115		
	Standby without cache retention	RTC running, CPU, 32KB RAM and (partial) register retention. RCOSC_LF	0.7		μA
		RTC running, CPU, 32KB RAM and (partial) register retention. XOSC_LF	0.8		
	Standby with cache retention	RTC running, CPU, 32KB RAM and (partial) register retention. RCOSC_LF	2.1		μA
		RTC running, CPU, 32KB RAM and (partial) register retention. XOSC_LF	2.2		
	Idle	Supply Systems and RAM powered. RCOSC_HF	570		μA
	Active	MCU running CoreMark at 48 MHz. RCOSC_HF	2.50		mA
Peripheral Current Consumption					
I_{peri}	Peripheral power domain	Delta current with domain enabled	47.0		μA
	Serial power domain	Delta current with domain enabled	3.3		
	RF Core	Delta current with power domain enabled, clock enabled, RF core idle	122		
	μDMA	Delta current with clock enabled, module is idle	58.1		
	Timers	Delta current with clock enabled, module is idle ⁽¹⁾	87.0		
	I2C	Delta current with clock enabled, module is idle	11.6		
	I2S	Delta current with clock enabled, module is idle	25.8		
	SSI	Delta current with clock enabled, module is idle	61.3		
	UART	Delta current with clock enabled, module is idle	125		
	CRYPTO (AES)	Delta current with clock enabled, module is idle	25.2		
	TRNG	Delta current with clock enabled, module is idle	23.3		

(1) Only one GPTimer running

7.6 Power Consumption - Radio Modes

When measured on the CC1311-P3EM-7XD7793-PA915 reference design with $T_c = 25^\circ\text{C}$, $V_{\text{DD5}} = 3.6\text{ V}$ with DC/DC enabled unless otherwise noted.

High power PA connected to V_{DD5} unless otherwise noted.

Using boost mode (increasing VDDR up to 1.95 V), will increase system current by 15% (does not apply to TX +14 dBm setting where this current is already included).

Relevant I_{core} and I_{peri} currents are included in below numbers.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Radio receive current, 868 MHz			5.4		mA
Radio transmit current Regular PA	0 dBm output power setting 868 MHz		7.4		mA
	+10 dBm output power setting 868 MHz		13.9		mA
Radio transmit current Boost mode, regular PA	+14 dBm output power setting 868 MHz		24.9		mA
Radio transmit current High-power PA	Transmit (TX), +20 dBm output power setting 915 MHz, $V_{\text{DD5}} = 3.3\text{ V}$		65		mA

7.7 Nonvolatile (Flash) Memory Characteristics

Over operating free-air temperature range and $V_{\text{DD5}} = 3.0\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Flash sector size			8		KB
Supported flash erase cycles before failure, full bank ^{(1) (5)}		30			k Cycles
Supported flash erase cycles before failure, single sector ⁽²⁾		60			k Cycles
Maximum number of write operations per row before sector erase ⁽³⁾				83	Write Operations
Flash retention	105 °C	11.4			Years
Flash sector erase current	Average delta current		9.7		mA
Flash sector erase time ⁽⁴⁾	Zero cycles		10		ms
	30k cycles			4000	ms
Flash write current	Average delta current, 4 bytes at a time		5.3		mA
Flash write time ⁽⁴⁾	4 bytes at a time		21.6		µs

- (1) A full bank erase is counted as a single erase cycle on each sector.
- (2) Up to 4 customer-designated sectors can be individually erased an additional 30k times beyond the baseline bank limitation of 30k cycles
- (3) Each wordline is 2048 bits (or 256 bytes) wide. This limitation corresponds to sequential memory writes of 4 (3.1) bytes minimum per write over a whole wordline. If additional writes to the same wordline are required, a sector erase is required once the maximum number of write operations per row is reached.
- (4) This number is dependent on Flash aging and increases over time and erase cycles
- (5) Aborting flash during erase or program modes is not a safe operation.

7.8 Thermal Resistance Characteristics

THERMAL METRIC ⁽¹⁾		PACKAGE	UNIT
		RGZ (VQFN)	
		48 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	25.0	°C/W ⁽²⁾
R _{θJC(top)}	Junction-to-case (top) thermal resistance	14.5	°C/W ⁽²⁾
R _{θJB}	Junction-to-board thermal resistance	8.7	°C/W ⁽²⁾
Ψ _{JT}	Junction-to-top characterization parameter	0.2	°C/W ⁽²⁾
Ψ _{JB}	Junction-to-board characterization parameter	8.6	°C/W ⁽²⁾
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	2.1	°C/W ⁽²⁾

- (1) For more information about traditional and new thermal metrics, see [Semiconductor and IC Package Thermal Metrics](#).

(2) °C/W = degrees Celsius per watt.

7.9 RF Frequency Bands

Over operating free-air temperature range (unless otherwise noted).

PARAMETER	MIN	TYP	MAX	UNIT
Frequency bands	1076		1315	MHz
	861		1054	
	431		527	
	359		439	
	287		351	
	143		176	

7.10 861MHz to 1054MHz—Receive (RX)

When measured on CC1311-P3EM-7XD7793-PA915 with $T_c = 25^\circ\text{C}$, $V_{\text{DDS}} = 3.0\text{V}$ with DC/DC enabled and high power PA connected to V_{DDS} unless otherwise noted.

All measurements are performed at the antenna input with a combined RX and TX path, except for high power PA which is measured at a dedicated antenna connection. All measurements are performed conducted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
General Parameters					
Digital channel filter programmable receive bandwidth		4		4000	kHz
Data rate step size			1.5		bps
Spurious emissions 25MHz to 1GHz	868MHz		< -57		dBm
Spurious emissions 1GHz to 13GHz	Conducted emissions measured according to ETSI EN 300 220		< -47		dBm
IEEE 802.15.4, 50kbps, ±25kHz Deviation, 2-GFSK, 100kHz RX Bandwidth					
Sensitivity	BER = 10^{-2} , 868MHz		-110		dBm
Saturation limit	BER = 10^{-2} , 868MHz		10		dBm
Selectivity, ±200kHz	BER = 10^{-2} , 868MHz ⁽¹⁾		44		dB
Selectivity, ±400kHz	BER = 10^{-2} , 868MHz ⁽¹⁾		48		dB
Blocking, ±1MHz	BER = 10^{-2} , 868MHz ⁽¹⁾		58		dB
Blocking, ±2MHz	BER = 10^{-2} , 868MHz ⁽¹⁾		62		dB
Blocking, ±5MHz	BER = 10^{-2} , 868MHz ⁽¹⁾		70		dB
Blocking, ±10MHz	BER = 10^{-2} , 868MHz ⁽¹⁾		77		dB
Image rejection (image compensation enabled)	BER = 10^{-2} , 868MHz ⁽¹⁾		41		dB
RSSI dynamic range	Starting from the sensitivity limit		95		dB
RSSI accuracy	Starting from the sensitivity limit across the given dynamic range		±3		dB
100kbps, ±25kHz Deviation, 2-GFSK, 137 kHz RX Bandwidth					
Sensitivity 100kbps	1% PER, 127 byte payload, 868MHz		-104		dBm
Selectivity, ±200kHz	1% PER, 127 byte payload, 868MHz. Wanted signal at -96dBm		31		dB
Selectivity, ±400kHz	1% PER, 127 byte payload, 868MHz. Wanted signal at -96dBm		37		dB
Co-channel rejection	1% PER, 127 byte payload, 868MHz. Wanted signal at -79dBm		-9		dB
200kbps, ±50kHz Deviation, 2-GFSK, 311 kHz RX Bandwidth					
Sensitivity	BER = 10^{-2} , 868MHz		-103		dBm
Sensitivity	BER = 10^{-2} , 915MHz		-102		dBm
Selectivity, ±400kHz	BER = 10^{-2} , 915MHz. Wanted signal 3dB above sensitivity limit.		45		dB
Selectivity, ±800kHz	BER = 10^{-2} , 915MHz. Wanted signal 3dB above sensitivity limit.		49		dB
Blocking, ±2MHz	BER = 10^{-2} , 915MHz. Wanted signal 3dB above sensitivity limit.		57		dB
Blocking, ±10MHz	BER = 10^{-2} , 915MHz. Wanted signal 3dB above sensitivity limit.		69		dB
500kbps, ±190kHz Deviation, 2-GFSK, 1150kHz RX Bandwidth					
Sensitivity 500kbps	1% PER, 127 byte payload, 915MHz		-94		dBm
Selectivity, ±1MHz	1% PER, 127 byte payload, 915MHz. Wanted signal at -88dBm		14		dB

7.10 861MHz to 1054MHz—Receive (RX) (continued)

When measured on CC1311-P3EM-7XD7793-PA915 with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{V}$ with DC/DC enabled and high power PA connected to V_{DD5} unless otherwise noted.

All measurements are performed at the antenna input with a combined RX and TX path, except for high power PA which is measured at a dedicated antenna connection. All measurements are performed conducted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Selectivity, $\pm 2\text{MHz}$	1% PER, 127 byte payload, 915MHz. Wanted signal at -88dBm		42		dB
Co-channel rejection	1% PER, 127 byte payload, 915MHz. Wanted signal at -71dBm		-9		dB
1 Mbps, $\pm 350\text{kHz}$ Deviation, 2-GFSK, 1.3MHz RX Bandwidth					
Sensitivity	BER = 10^{-2} , 868MHz		-97		dBm
Sensitivity	BER = 10^{-2} , 915MHz		-96		dBm
Blocking, +2MHz	BER = 10^{-2} , 915MHz. Wanted signal 3dB above sensitivity limit.		43		dB
Blocking, -2MHz	BER = 10^{-2} , 915MHz. Wanted signal 3dB above sensitivity limit.		26		dB
Blocking, +10MHz	BER = 10^{-2} , 915MHz. Wanted signal 3dB above sensitivity limit.		54		dB
Blocking, -10MHz	BER = 10^{-2} , 915MHz. Wanted signal 3dB above sensitivity limit.		48		dB
SimpleLink™ Long Range, 2.5/5kbps (20ksp), $\pm 5\text{kHz}$ Deviation, 2-GFSK, 34kHz RX Bandwidth, FEC = 1:2, DSSS = 1:4/1:2					
Sensitivity	2.5kbps, BER = 10^{-2} , 868MHz		-121		dBm
Sensitivity	5kbps, BER = 10^{-2} , 868MHz		-119		dBm
Saturation limit	2.5kbps, BER = 10^{-2} , 868MHz		10		dBm
Selectivity, $\pm 100\text{kHz}$	2.5kbps, BER = 10^{-2} , 868MHz ⁽¹⁾		49		dB
Selectivity, $\pm 200\text{kHz}$	2.5kbps, BER = 10^{-2} , 868MHz ⁽¹⁾		50		dB
Selectivity, $\pm 300\text{kHz}$	2.5kbps, BER = 10^{-2} , 868MHz ⁽¹⁾		51		dB
Blocking, $\pm 1\text{MHz}$	2.5kbps, BER = 10^{-2} , 868MHz ⁽¹⁾		63		dB
Blocking, $\pm 2\text{MHz}$	2.5kbps, BER = 10^{-2} , 868MHz ⁽¹⁾		69		dB
Blocking, $\pm 5\text{MHz}$	2.5kbps, BER = 10^{-2} , 868MHz ⁽¹⁾		79		dB
Blocking, $\pm 10\text{MHz}$	2.5kbps, BER = 10^{-2} , 868MHz ⁽¹⁾		88		dB
Image rejection (image compensation enabled)	2.5kbps, BER = 10^{-2} , 868MHz ⁽¹⁾		47		dB
RSSI dynamic range	Starting from the sensitivity limit		97		dB
RSSI accuracy	Starting from the sensitivity limit across the given dynamic range		± 3		dB
Narrowband, 9.6kbps, $\pm 2.4\text{kHz}$ Deviation, 2-GFSK, 17.1kHz RX Bandwidth					
Sensitivity	BER = 10^{-2} , 868MHz		-117		dBm
Adjacent Channel Rejection	BER = 10^{-2} , 868MHz. Wanted signal 3dB above the ETSI reference sensitivity limit (-104.6dBm). Interferer $\pm 20\text{kHz}$		41		dB
Alternate Channel Rejection	BER = 10^{-2} , 868MHz. Wanted signal 3dB above the ETSI reference sensitivity limit (-104.6dBm). Interferer $\pm 40\text{kHz}$		42		dB
Blocking, $\pm 1\text{MHz}$	BER = 10^{-2} , 868MHz. Wanted signal 3dB above the ETSI reference sensitivity limit (-104.6dBm).		65		dB
Blocking, $\pm 2\text{MHz}$	BER = 10^{-2} , 868MHz. Wanted signal 3dB above the ETSI reference sensitivity limit (-104.6dBm).		70		dB
Blocking, $\pm 10\text{MHz}$	BER = 10^{-2} , 868MHz. Wanted signal 3dB above the ETSI reference sensitivity limit (-104.6dBm).		85		dB
Wi-SUN, 2-GFSK					
Sensitivity	50kbps, $\pm 12.5\text{kHz}$ deviation, 2-GFSK, 68kHz RX Bandwidth, 868MHz, 10% PER, 250 byte payload		-107		dBm
Selectivity, $\pm 100\text{kHz}$, 50kbps, $\pm 12.5\text{kHz}$ deviation, 2-GFSK, 868.3MHz	50kbps, $\pm 12.5\text{kHz}$ deviation, 2-GFSK, 68kHz RX Bandwidth, 868.3MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		30		dB
Selectivity, $\pm 200\text{kHz}$, 50kbps, $\pm 12.5\text{kHz}$ deviation, 2-GFSK, 868.3MHz	50kbps, $\pm 12.5\text{kHz}$ deviation, 2-GFSK, 68kHz RX Bandwidth, 868.3MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		36		dB
Sensitivity	50kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 98kHz RX Bandwidth, 918.2MHz, 10% PER, 250 byte payload		-106		dBm
Selectivity, $\pm 200\text{kHz}$, 50kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 918.2MHz	50kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 98kHz RX Bandwidth, 918.2MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		34		dB

7.10 861MHz to 1054MHz—Receive (RX) (continued)

When measured on CC1311-P3EM-7XD7793-PA915 with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{V}$ with DC/DC enabled and high power PA connected to V_{DD5} unless otherwise noted.

All measurements are performed at the antenna input with a combined RX and TX path, except for high power PA which is measured at a dedicated antenna connection. All measurements are performed conducted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Selectivity, $\pm 400\text{kHz}$, 50kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 918.2MHz	50kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 98kHz RX Bandwidth, 918.2MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		41		dB
Sensitivity	100kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 135kHz RX Bandwidth, 868MHz, 10% PER, 250 byte payload		-104		dBm
Selectivity, $\pm 200\text{kHz}$, 100kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 868.3MHz	100kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 135kHz RX Bandwidth, 868.3MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		37		dB
Selectivity, $\pm 400\text{kHz}$, 100kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 868.3MHz	100kbps, $\pm 25\text{kHz}$ deviation, 2-GFSK, 135kHz RX Bandwidth, 868.3MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		45		dB
Sensitivity	100kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 196kHz RX Bandwidth, 920.9MHz, 10% PER, 250 byte payload		-102		dBm
Selectivity, $\pm 400\text{kHz}$, 100kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 920.9MHz	100kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 196kHz RX Bandwidth, 920.9MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		40		dB
Selectivity, $\pm 800\text{kHz}$, 100kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 920.9MHz	100kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 196kHz RX Bandwidth, 920.9MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		49		dB
Sensitivity	150kbps, $\pm 37.5\text{kHz}$ deviation, 2-GFSK, 273kHz RX Bandwidth, 920.9MHz, 10% PER, 250 byte payload		-99		dBm
Selectivity, $\pm 400\text{kHz}$, 150kbps, $\pm 37.5\text{kHz}$ deviation, 2-GFSK, 920.9MHz	150kbps, $\pm 37.5\text{kHz}$ deviation, 2-GFSK, 273kHz RX Bandwidth, 920.9MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		41		dB
Selectivity, $\pm 800\text{kHz}$, 150kbps, $\pm 37.5\text{kHz}$ deviation, 2-GFSK, 920.9MHz	150kbps, $\pm 37.5\text{kHz}$ deviation, 2-GFSK, 273kHz RX Bandwidth, 920.9MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		47		dB
Sensitivity	200kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 918.4MHz, 273kHz RX BW, 10% PER, 250 byte payload		-99		dBm
Selectivity, $\pm 400\text{kHz}$, 200kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 918.4MHz	200kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 273kHz RX Bandwidth, 918.4MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		42		dB
Selectivity, $\pm 800\text{kHz}$, 200kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 918.4MHz	200kbps, $\pm 50\text{kHz}$ deviation, 2-GFSK, 273kHz RX Bandwidth, 918.4MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		49		dB
Sensitivity	200kbps, $\pm 100\text{kHz}$ deviation, 2-GFSK, 273kHz RX Bandwidth, 920.8MHz, 10% PER, 250 byte payload		-99		dBm
Selectivity, $\pm 600\text{kHz}$, 200kbps, $\pm 100\text{kHz}$ deviation, 2-GFSK, 920.8MHz	200kbps, $\pm 100\text{kHz}$ deviation, 2-GFSK, 273kHz RX Bandwidth, 920.8MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		45		dB
Selectivity, $\pm 1200\text{kHz}$, 200kbps, $\pm 100\text{kHz}$ deviation, 2-GFSK, 920.8MHz	200kbps, $\pm 100\text{kHz}$ deviation, 2-GFSK, 273kHz RX Bandwidth, 920.8MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		52		dB
Sensitivity	300kbps, $\pm 75\text{kHz}$ deviation, 2-GFSK, 917.6MHz, 498kHz RX BW, 10% PER, 250 byte payload		-97		dBm
Selectivity, $\pm 600\text{kHz}$, 300kbps, $\pm 75\text{kHz}$ deviation, 2-GFSK, 917.6MHz	300kbps, $\pm 75\text{kHz}$ deviation, 2-GFSK, 498kHz RX Bandwidth, 917.6MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		42		dB
Selectivity, $\pm 1200\text{kHz}$, 300kbps, $\pm 75\text{kHz}$ deviation, 2-GFSK, 917.6MHz	300kbps, $\pm 75\text{kHz}$ deviation, 2-GFSK, 498kHz RX Bandwidth, 917.6MHz, 10% PER, 250 byte payload. Wanted signal 3dB above sensitivity level		47		dB

(1) Wanted signal 3dB above the reference sensitivity limit according to ETSI EN 300 220V. 3.1.1

7.11 861 MHz to 1054 MHz - Transmit (TX)

Measured on the CC1311-P3EM-7XD7793-PA915 reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$ with DC/DC enabled and high power PA connected to V_{DD5} using 2-GFSK, 50 kbps, $\pm 25\text{ kHz}$ deviation unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path, except for high power PA which is measured at a dedicated antenna connection. All measurements are performed conducted. ⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
General parameters						
Max output power, boost mode Regular PA		VDDR = 1.95 V Minimum supply voltage (VDDS) for boost mode is 2.1 V 868 MHz and 915 MHz		14		dBm
Max output power, Regular PA		868 MHz and 915 MHz		13		dBm
Max output power, High power PA		915 MHz VDDS = 3.3V		20		dBm
Output power programmable range Regular PA		868 MHz and 915 MHz		24		dB
Output power programmable range High power PA		868 MHz and 915 MHz VDDS = 3.3V		6		dB
Output power variation over temperature Regular PA		+10 dBm setting Over recommended temperature operating range		± 2		dB
Output power variation over temperature Boost mode, regular PA		+14 dBm setting Over recommended temperature operating range		± 1.5		dB
Spurious emissions and harmonics						
Spurious emissions (excluding harmonics) Regular PA ⁽²⁾	30 MHz to 1 GHz	+14 dBm setting ETSI restricted bands		< -54		dBm
		+14 dBm setting ETSI outside restricted bands		< -36		dBm
	1 GHz to 12.75 GHz (outside ETSI restricted bands)	+14 dBm setting measured in 1 MHz bandwidth (ETSI)		< -30		dBm
Spurious emissions out- of-band Regular PA, 915 MHz ⁽²⁾	30 MHz to 88 MHz (within FCC restricted bands)	+14 dBm setting		< -56		dBm
	88 MHz to 216 MHz (within FCC restricted bands)	+14 dBm setting		< -52		dBm
	216 MHz to 960 MHz (within FCC restricted bands)	+14 dBm setting		< -50		dBm
	960 MHz to 2390 MHz and above 2483.5 MHz (within FCC restricted band)	+14 dBm setting		< -42		dBm
	1 GHz to 12.75 GHz (outside FCC restricted bands)	+14 dBm setting		< -40		dBm
Spurious emissions out- of-band High power PA, 915 MHz ⁽²⁾ ⁽³⁾	30 MHz to 88 MHz (within FCC restricted bands)	+20 dBm setting, VDDS = 3.3 V		< -55		dBm
	88 MHz to 216 MHz (within FCC restricted bands)	+20 dBm setting, VDDS = 3.3 V		< -52		dBm
	216 MHz to 960 MHz (within FCC restricted bands)	+20 dBm setting, VDDS = 3.3 V		< -49		dBm
	960 MHz to 2390 MHz and above 2483.5 MHz (within FCC restricted band)	+20 dBm setting, VDDS = 3.3 V		< -41		dBm
	1 GHz to 12.75 GHz (outside FCC restricted bands)	+20 dBm setting, VDDS = 3.3 V		< -20		dBm

7.11 861 MHz to 1054 MHz - Transmit (TX) (continued)

Measured on the CC1311-P3EM-7XD7793-PA915 reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$ with DC/DC enabled and high power PA connected to V_{DD5} using 2-GFSK, 50 kbps, $\pm 25\text{ kHz}$ deviation unless otherwise noted. All measurements are performed at the antenna input with a combined RX and TX path, except for high power PA which is measured at a dedicated antenna connection. All measurements are performed conducted. ⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Spurious emissions out-of-band Regular PA, 920.6/928 MHz ⁽²⁾	Below 710 MHz (ARIB T-108)	+14 dBm setting		< -36		dBm
	710 MHz to 900 MHz (ARIB T-108)	+14 dBm setting		< -55		dBm
	900 MHz to 915 MHz (ARIB T-108)	+14 dBm setting		< -55		dBm
	930 MHz to 1000 MHz (ARIB T-108)	+14 dBm setting		< -55		dBm
	1000 MHz to 1215 MHz (ARIB T-108)	+14 dBm setting		< -45		dBm
	Above 1215 MHz (ARIB T-108)	+14 dBm setting		< -30		dBm
Harmonics Regular PA	Second harmonic	+14 dBm setting, 868 MHz		< -30		dBm
		+14 dBm setting, 915 MHz		< -30		
	Third harmonic	+14 dBm setting, 868 MHz		< -30		dBm
		+14 dBm setting, 915 MHz		< -42		
	Fourth harmonic	+14 dBm setting, 868 MHz		< -30		dBm
		+14 dBm setting, 915 MHz		< -30		
	Fifth harmonic	+14 dBm setting, 868 MHz		< -30		dBm
		+14 dBm setting, 915 MHz		< -42		
Harmonics High power PA	Second harmonic	+20 dBm setting, $V_{DD5} = 3.3\text{ V}$, 915 MHz		< -30		dBm
	Third harmonic	+20 dBm setting, $V_{DD5} = 3.3\text{ V}$, 915 MHz		< -42		dBm
	Fourth harmonic	+20 dBm setting, $V_{DD5} = 3.3\text{ V}$, 915 MHz		< -30		dBm
	Fifth harmonic	+20 dBm setting, $V_{DD5} = 3.3\text{ V}$, 915 MHz		< -42		dBm
Adjacent Channel Power						
Adjacent channel power, regular 14 dBm PA	Adjacent channel, 20 kHz offset. 9.6 kbps, $h=0.5$	12.5 dBm setting. 868.3 MHz. 14 kHz channel BW		-23		dBm
Alternate channel power, regular 14 dBm PA	Alternate channel, 40 kHz offset. 9.6 kbps, $h=0.5$	12.5 dBm setting. 868.3 MHz. 14 kHz channel BW		-30		dBm

- (1) Some combinations of frequency, data rate and modulation format requires use of external crystal load capacitors for regulatory compliance. More details can be found in the device errata.
- (2) Suitable for systems targeting compliance with EN 300 220, EN 303 131, EN 303 204, FCC CFR47 Part 15, ARIB STD-T108.
- (3) Spurious emissions increase for supply voltages below 2.2 V. As such, care must be taken to ensure regulatory requirements are met when operating at low supply voltage levels. An alternative is to use the Sub-1 GHz PA below 2.2 V.

7.12 861 MHz to 1054 MHz - PLL Phase Noise Wideband Mode

When measured on the CC1311-P3EM-7XD7793-PA915 reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Phase noise in the 868- and 915-MHz bands 20 kHz PLL loop bandwidth	$\pm 10\text{ kHz}$ offset		-76		dBc/Hz
	$\pm 100\text{ kHz}$ offset		-98		dBc/Hz
	$\pm 200\text{ kHz}$ offset		-106		dBc/Hz
	$\pm 400\text{ kHz}$ offset		-113		dBc/Hz
	$\pm 1000\text{ kHz}$ offset		-122		dBc/Hz
	$\pm 2000\text{ kHz}$ offset		-130		dBc/Hz
	$\pm 10000\text{ kHz}$ offset		-140		dBc/Hz

7.13 861 MHz to 1054 MHz - PLL Phase Noise Narrowband Mode

When measured on the CC1311-P3EM-7XD7793-PA915 reference design with $T_c = 25^\circ\text{C}$, $V_{\text{DD5}} = 3.0\text{ V}$.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Phase noise in the 868- and 915-MHz bands 150 kHz PLL loop bandwidth	±10 kHz offset		-95		dBc/Hz
	±100 kHz offset		-94		dBc/Hz
	±200 kHz offset		-94		dBc/Hz
	±400 kHz offset		-103		dBc/Hz
	±1000 kHz offset		-119		dBc/Hz
	±2000 kHz offset		-129		dBc/Hz
	±10000 kHz offset		-138		dBc/Hz

7.14 359MHz to 527MHz—Receive (RX)

When measured on a CC1311-P3EM-7XD7793-PA915 reference design with $T_c = 25^\circ\text{C}$, $V_{\text{DD5}} = 3.0\text{V}$ with DC/DC enabled and high power PA connected to V_{DD5} unless otherwise noted.

All measurements are performed at the antenna input with a combined RX and TX path, except for high-power PA, which is measured at a dedicated antenna connection. All measurements are performed conducted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
General Parameters					
Spurious emissions 25MHz to 1GHz	433.92MHz		< -57		dBm
Spurious emissions 1GHz to 13GHz	Conducted emissions measured according to ETSI EN 300 220		< -47		dBm
IEEE 802.15.4, 50kbps, ±25kHz Deviation, 2-GFSK, 78kHz RX Bandwidth					
Sensitivity	BER = 10^{-2} , 433.92MHz		-110		dBm
Saturation limit	BER = 10^{-2} , 433.92MHz		10		dBm
Selectivity, +200kHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		48		dB
Selectivity, -200kHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		43		dB
Selectivity, +400kHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		53		dB
Selectivity, -400kHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		44		dB
Blocking, +1MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		60		dB
Blocking, -1MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		54		dB
Blocking, +2MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		62		dB
Blocking, -2MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		61		dB
Blocking, +10MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		75		dB
Blocking, -10MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		75		dB
Image rejection (image compensation enabled)	BER = 10^{-2} , 433.92MHz ⁽¹⁾		44		dB
RSSI dynamic range	Starting from the sensitivity limit		95		dB
RSSI accuracy	Starting from the sensitivity limit across the given dynamic range		±3		dB
200kbps, ±50kHz Deviation, 2-GFSK, 273kHz RX Bandwidth					
Sensitivity	BER = 10^{-2} , 433.92MHz		-104		dBm
Saturation limit	BER = 10^{-2} , 433.92MHz		10		dBm
Selectivity, ±400kHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		48		dB
Blocking, ±1MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		52		dB
Blocking, ±2MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		55		dB
Blocking, ±10MHz	BER = 10^{-2} , 433.92MHz ⁽¹⁾		68		dB
Image rejection (image compensation enabled)	BER = 10^{-2} , 433.92MHz ⁽¹⁾		45		dB
RSSI dynamic range	Starting from the sensitivity limit		89		dB
RSSI accuracy	Starting from the sensitivity limit across the given dynamic range		±3		dB
SimpleLink™ Long Range, 2.5/5kbps (20 ksps), ±5kHz Deviation, 2-GFSK, 34kHz RX Bandwidth, FEC = 1:2, DSSS = 1:4/1:2					
Sensitivity	2.5kbps, BER = 10^{-2} , 433.92MHz		-121		dBm
Sensitivity	5kbps, BER = 10^{-2} , 433.92MHz		-119		dBm

7.14 359MHz to 527MHz—Receive (RX) (continued)

When measured on a CC1311-P3EM-7XD7793-PA915 reference design with $T_c = 25^\circ\text{C}$, $V_{\text{DD}} = 3.0\text{V}$ with DC/DC enabled and high power PA connected to V_{DD} unless otherwise noted.

All measurements are performed at the antenna input with a combined RX and TX path, except for high-power PA, which is measured at a dedicated antenna connection. All measurements are performed conducted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Saturation limit	5kbps, BER = 10^{-2} , 433.92MHz		10		dBm
Selectivity, +100kHz	5kbps, BER = 10^{-2} , 433.92MHz ⁽¹⁾		55		dB
Selectivity, -100kHz	5kbps, BER = 10^{-2} , 433.92MHz ⁽¹⁾		53		dB
Blocking, +1MHz	5kbps, BER = 10^{-2} , 433.92MHz ⁽¹⁾		69		dB
Blocking, -1MHz	5kbps, BER = 10^{-2} , 433.92MHz ⁽¹⁾		65		dB
Blocking, +2MHz	5kbps, BER = 10^{-2} , 433.92MHz ⁽¹⁾		71		dB
Blocking, -2MHz	5kbps, BER = 10^{-2} , 433.92MHz ⁽¹⁾		70		dB
Blocking, +10MHz	5kbps, BER = 10^{-2} , 433.92MHz ⁽¹⁾		84		dB
Blocking, -10MHz	5kbps, BER = 10^{-2} , 433.92MHz ⁽¹⁾		84		dB
Image rejection (image compensation enabled)	5kbps, BER = 10^{-2} , 433.92MHz		49		dB
RSSI dynamic range	Starting from the sensitivity limit		101		dB
RSSI accuracy	Starting from the sensitivity limit across the given dynamic range		±3		dB

(1) Wanted signal 3dB above sensitivity limit

7.15 359 MHz to 527 MHz - Transmit (TX)

Measured on the LAUNCHXL-CC1352P-4 reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$ with DC/DC enabled unless otherwise noted.

All measurements are performed at the antenna input with a combined RX and TX path, except for high power PA which is measured at a dedicated antenna connection. All measurements are performed conducted. ⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
General parameters						
Max output power, Regular PA		433.92 MHz, without BOOST ($V_{DDR} = 1.7\text{ V}$)		13		dBm
Output power programmable range Regular PA		433.92 MHz, without BOOST ($V_{DDR} = 1.7\text{ V}$)		24		dB
Output power variation over temperature, regular PA		+13 dBm setting, 433.92 MHz Over recommended temperature operating range		± 1.5		dB
Spurious emissions and harmonics						
Spurious emissions (excluding harmonics) Regular PA ⁽²⁾	30 MHz to 1 GHz	+10 dBm setting ETSI restricted bands		< -54		dBm
		+10 dBm setting ETSI outside restricted bands		< -36		dBm
	1 GHz to 12.75 GHz (outside ETSI restricted bands)	+10 dBm setting measured in 1 MHz bandwidth (ETSI)		< -30		dBm
Spurious emissions out-of-band Regular PA, 429 MHz ⁽²⁾	Outside the necessary frequency band (ARIB T-67)	+10 dBm setting		< -26		dBm
	710 MHz to 900 MHz (ARIB T-67)	+10 dBm setting		< -55		dBm
	900 MHz to 915 MHz (ARIB T-67)	+10 dBm setting		< -55		dBm
	930 MHz to 1000 MHz (ARIB T-67)	+10 dBm setting		< -55		dBm
	1000 MHz to 1215 MHz (ARIB T-67)	+10 dBm setting		< -45		dBm
	Above 1215 MHz (ARIB T-67)	+10 dBm setting		< -30		dBm
Harmonics Regular PA	Second harmonic	+13 dBm setting, 433 MHz		< -36		dBm
Harmonics Regular PA	Third harmonic	+13 dBm setting, 433 MHz		< -30		dBm
Harmonics Regular PA	Fourth harmonic	+13 dBm setting, 433 MHz		< -30		dBm
Harmonics Regular PA	Fifth harmonic	+13 dBm setting, 433 MHz		< -30		dBm

(1) Some combinations of frequency, data rate and modulation format requires use of external crystal load capacitors for regulatory compliance. More details can be found in the device errata.

(2) Suitable for systems targeting compliance with EN 300 220, EN 303 131, EN 303 204, FCC CFR47 Part 15, ARIB STD-T108.

7.16 359 MHz to 527 MHz - PLL Phase Noise

When measured on the LAUNCHXL-CC1352P-4 reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Phase noise in the 433 MHz band 20 kHz PLL loop bandwidth	$\pm 10\text{ kHz}$ offset		-82		dBc/Hz
	$\pm 100\text{ kHz}$ offset		-105		dBc/Hz
	$\pm 200\text{ kHz}$ offset		-112		dBc/Hz
	$\pm 400\text{ kHz}$ offset		-119		dBc/Hz
	$\pm 1000\text{ kHz}$ offset		-127		dBc/Hz
	$\pm 2000\text{ kHz}$ offset		-133		dBc/Hz
	$\pm 10000\text{ kHz}$ offset		-141		dBc/Hz

7.17 Timing and Switching Characteristics

7.17.1 Reset Timing

PARAMETER	MIN	TYP	MAX	UNIT
RESET_N low duration	1			μs

7.17.2 Wakeup Timing

Measured over operating free-air temperature with $V_{DD5} = 3.0\text{ V}$ (unless otherwise noted). The times listed here do not include software overhead.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
MCU, Reset to Active		850 - 4000			μs
MCU, Shutdown to Active		850 - 4000			μs
MCU, Standby to Active		160			μs
MCU, Active to Standby		36			μs
MCU, Idle to Active		14			μs

7.17.3 Clock Specifications

7.17.3.1 48 MHz Crystal Oscillator (XOSC_HF)

Measured on a Texas Instruments reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$, unless otherwise noted.⁽¹⁾

	PARAMETER	MIN	TYP	MAX	UNIT
	Crystal frequency		48		MHz
ESR	Equivalent series resistance $6\text{ pF} < C_L \leq 9\text{ pF}$		20	60	Ω
ESR	Equivalent series resistance $5\text{ pF} < C_L \leq 6\text{ pF}$			80	Ω
L_M	Motional inductance, relates to the load capacitance that is used for the crystal (C_L in Farads) ⁽⁵⁾		$< 3 \times 10^{-25} / C_L^2$		H
C_L	Crystal load capacitance ⁽⁴⁾	5	7 ⁽³⁾	9	pF
	Start-up time ⁽²⁾		200		μs

- (1) Probing or otherwise stopping the crystal while the DC/DC converter is enabled may cause permanent damage to the device.
- (2) Start-up time using the TI-provided power driver. Start-up time may increase if driver is not used.
- (3) On-chip default connected capacitance including reference design parasitic capacitance. Connected internal capacitance is changed through software in the Customer Configuration section (CCFG).
- (4) Adjustable load capacitance is integrated into the device. External load capacitors are required for systems targeting compliance with certain regulations. See the device errata for further details.
- (5) The crystal manufacturer's specification must satisfy this requirement for proper operation.

7.17.3.2 48 MHz RC Oscillator (RCOSC_HF)

Measured on a Texas Instruments reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$, unless otherwise noted.

	MIN	TYP	MAX	UNIT
Frequency		48		MHz
Uncalibrated frequency accuracy		± 1		%
Calibrated frequency accuracy ⁽¹⁾		± 0.25		%
Start-up time		5		μs

- (1) Accuracy relative to the calibration source (XOSC_HF)

7.17.3.3 32.768 kHz Crystal Oscillator (XOSC_LF)

Measured on a Texas Instruments reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$, unless otherwise noted.

	MIN	TYP	MAX	UNIT
Crystal frequency		32.768		kHz
ESR		30	100	k Ω
C_L	6	7 ⁽¹⁾	12	pF

- (1) Default load capacitance using TI reference designs including parasitic capacitance. Crystals with different load capacitance may be used.

7.17.3.4 32 kHz RC Oscillator (RCOSC_LF)

Measured on a Texas Instruments reference design with $T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$, unless otherwise noted.

		MIN	TYP	MAX	UNIT
Calibrated frequency			32.8		kHz
Calibrated RTC variation ⁽¹⁾	Calibrated periodically against XOSC_HF ⁽²⁾		±600 ⁽³⁾		ppm
Temperature coefficient.			50		ppm/°C

- (1) When using RCOSC_LF as source for the low frequency system clock (SCLK_LF), the accuracy of the SCLK_LF-derived Real Time Clock (RTC) can be improved by measuring RCOSC_LF relative to XOSC_HF and compensating for the RTC tick speed. This functionality is available through the TI-provided Power driver.
- (2) TI driver software calibrates the RTC every time XOSC_HF is enabled.
- (3) Some device's variation can exceed 1000 ppm. Further calibration will not improve variation.

7.17.4 Synchronous Serial Interface (SSI) Characteristics

7.17.4.1 Synchronous Serial Interface (SSI) Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER NO.	PARAMETER		MIN	TYP	MAX	UNIT
S1	$t_{\text{clk_per}}$	SSIClk cycle time	12		65024	System Clocks ⁽²⁾
S2 ⁽¹⁾	$t_{\text{clk_high}}$	SSIClk high time		0.5		$t_{\text{clk_per}}$
S3 ⁽¹⁾	$t_{\text{clk_low}}$	SSIClk low time		0.5		$t_{\text{clk_per}}$

(1) Refer to SSI timing diagrams [Figure 7-1](#), [Figure 7-2](#), and [Figure 7-3](#).

(2) When using the TI-provided Power driver, the SSI system clock is always 48 MHz.

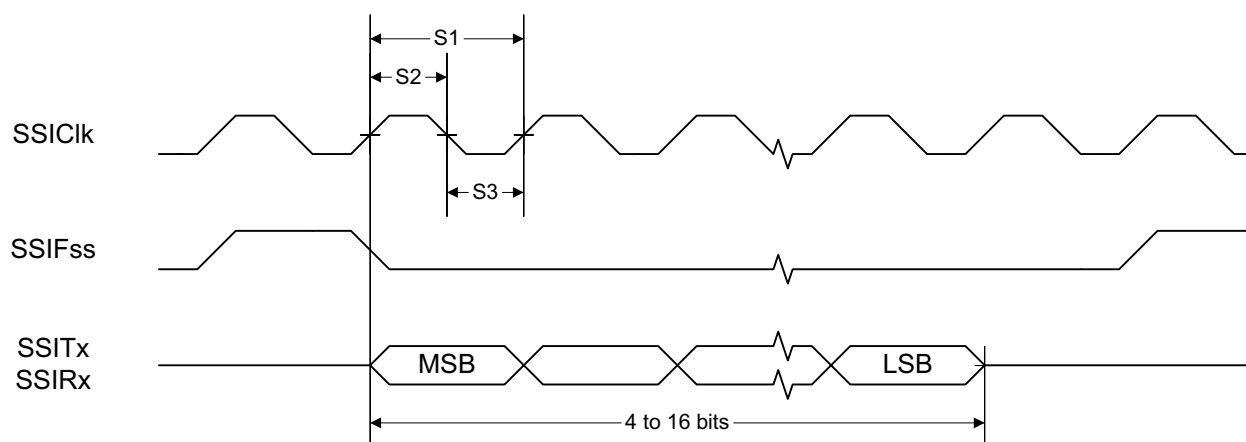


Figure 7-1. SSI Timing for TI Frame Format (FRF = 01), Single Transfer Timing Measurement

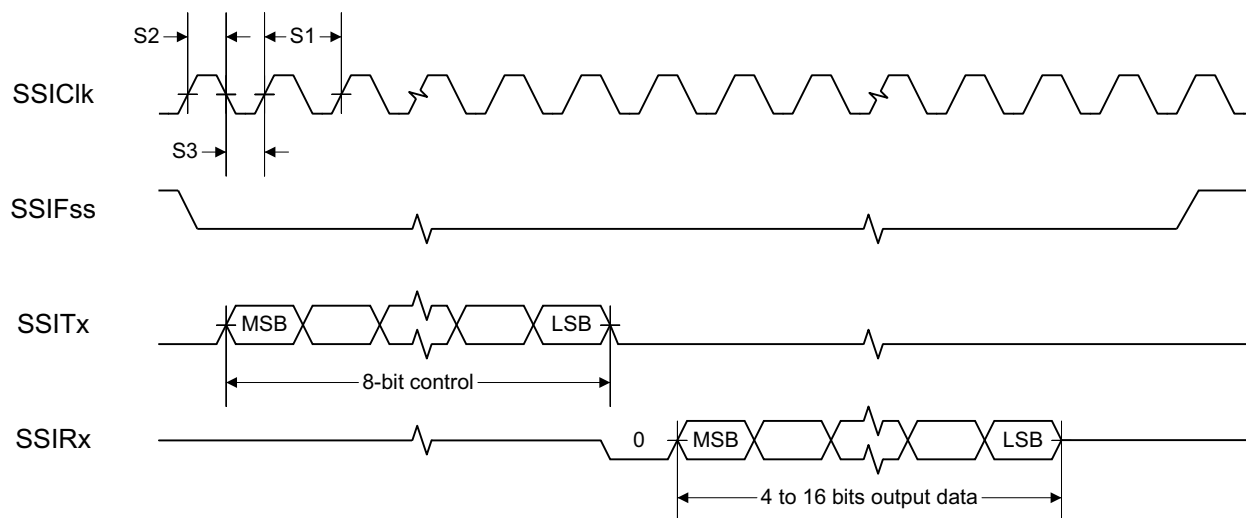


Figure 7-2. SSI Timing for MICROWIRE Frame Format (FRF = 10), Single Transfer

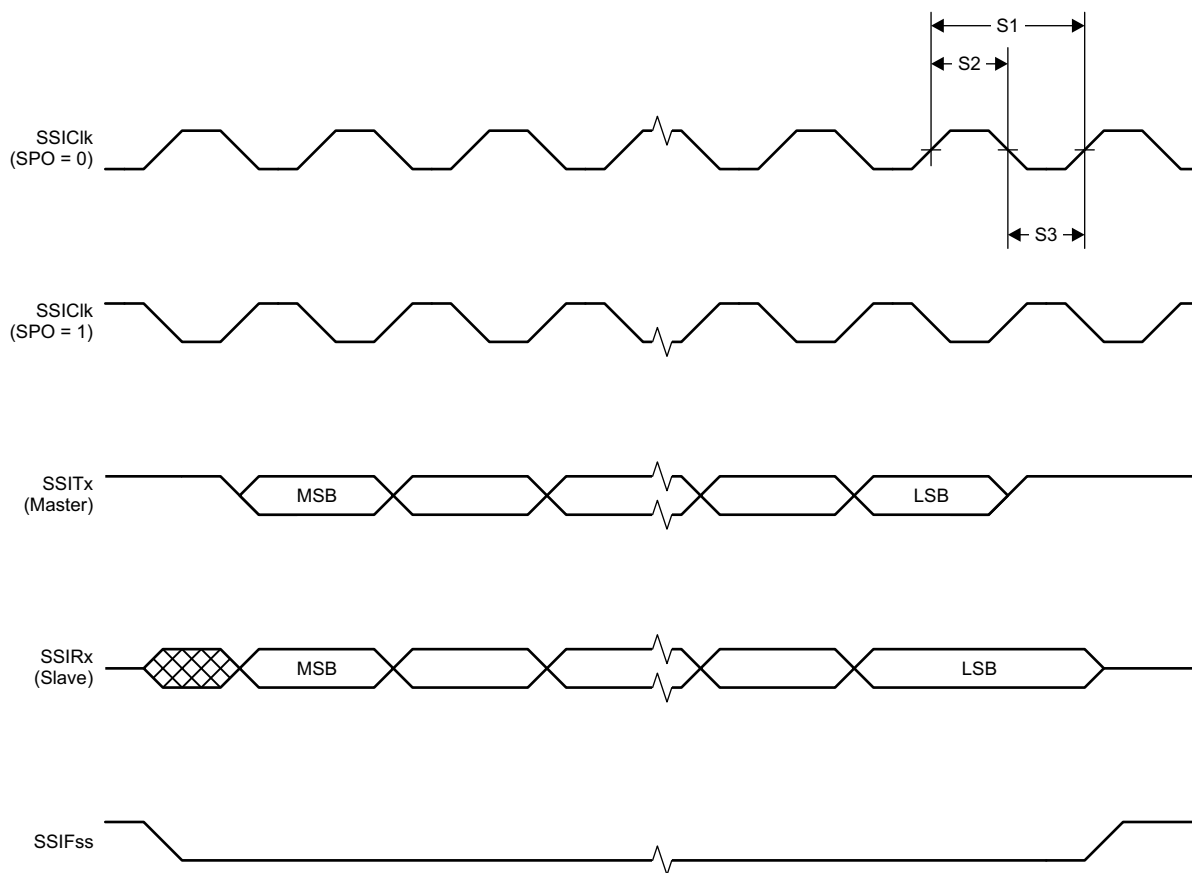


Figure 7-3. SSI Timing for SPI Frame Format (FRF = 00), With SPH = 1

7.17.5 UART

7.17.5.1 UART Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER	MIN	TYP	MAX	UNIT
UART rate			3	MBaud

7.18 Peripheral Characteristics

7.18.1 ADC

7.18.1.1 Analog-to-Digital Converter (ADC) Characteristics

$T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$ and voltage scaling enabled, unless otherwise noted.⁽¹⁾

Performance numbers require use of offset and gain adjustments in software by TI-provided ADC drivers.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage range		0		V _{DD5}	V
Resolution			12		Bits
Sample Rate				200	ksps
Offset	Internal 4.3 V equivalent reference ⁽²⁾		−0.24		LSB
Gain error	Internal 4.3 V equivalent reference ⁽²⁾		7.14		LSB
DNL ⁽⁴⁾	Differential nonlinearity		>−1		LSB
INL	Integral nonlinearity		±4		LSB
ENOB	Effective number of bits	Internal 4.3 V equivalent reference ⁽²⁾ , 200 kSamples/s, 9.6 kHz input tone		9.8	Bits
		Internal 4.3 V equivalent reference ⁽²⁾ , 200 kSamples/s, 9.6 kHz input tone, DC/DC enabled		9.8	
		V _{DD5} as reference, 200 kSamples/s, 9.6 kHz input tone		10.1	
		Internal reference, voltage scaling disabled, 32 samples average (software), 200 kSamples/s, 300 Hz input tone		11.1	
		Internal reference, voltage scaling disabled, 14-bit mode, 200 kSamples/s, 300 Hz input tone ⁽⁵⁾		11.3	
		Internal reference, voltage scaling disabled, 15-bit mode, 200 kSamples/s, 300 Hz input tone ⁽⁵⁾		11.6	
THD	Total harmonic distortion	Internal 4.3 V equivalent reference ⁽²⁾ , 200 kSamples/s, 9.6 kHz input tone		−65	dB
		V _{DD5} as reference, 200 kSamples/s, 9.6 kHz input tone		−70	
		Internal reference, voltage scaling disabled, 32 samples average, 200 kSamples/s, 300 Hz input tone		−72	
SINAD, SNDR	Signal-to-noise and distortion ratio	Internal 4.3 V equivalent reference ⁽²⁾ , 200 kSamples/s, 9.6 kHz input tone		60	dB
		V _{DD5} as reference, 200 kSamples/s, 9.6 kHz input tone		63	
		Internal reference, voltage scaling disabled, 32 samples average (software), 200 kSamples/s, 300 Hz input tone		68	
SFDR	Spurious-free dynamic range	Internal 4.3 V equivalent reference ⁽²⁾ , 200 kSamples/s, 9.6 kHz input tone		70	dB
		V _{DD5} as reference, 200 kSamples/s, 9.6 kHz input tone		73	
		Internal reference, voltage scaling disabled, 32 samples average (software), 200 kSamples/s, 300 Hz input tone		75	
	Conversion time	Serial conversion, time-to-output, 24 MHz clock		50	Clock Cycles
	Current consumption	Internal 4.3 V equivalent reference ⁽²⁾		0.39	mA
	Current consumption	V _{DD5} as reference		0.56	mA
	Reference voltage	Equivalent fixed internal reference (input voltage scaling enabled). For best accuracy, the ADC conversion should be initiated through the TI-RTOS API in order to include the gain/offset compensation factors stored in FCFG1		4.3 ^{(2) (3)}	V

7.18.1.1 Analog-to-Digital Converter (ADC) Characteristics (continued)

$T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$ and voltage scaling enabled, unless otherwise noted.⁽¹⁾

Performance numbers require use of offset and gain adjustments in software by TI-provided ADC drivers.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Reference voltage	Fixed internal reference (input voltage scaling disabled). For best accuracy, the ADC conversion should be initiated through the TI-RTOS API in order to include the gain/offset compensation factors stored in FCFG1. This value is derived from the scaled value (4.3 V) as follows: $V_{ref} = 4.3\text{ V} \times 1408 / 4095$		1.48		V
Reference voltage	VDDS as reference, input voltage scaling enabled		VDDS		V
Reference voltage	VDDS as reference, input voltage scaling disabled		VDDS / 2.82 ⁽³⁾		V
Input impedance	200 kSamples/s, voltage scaling enabled. Capacitive input, Input impedance depends on sampling frequency and sampling time		>1		MΩ

- (1) Using IEEE Std 1241-2010 for terminology and test methods
- (2) Input signal scaled down internally before conversion, as if voltage range was 0 to 4.3 V
- (3) Applied voltage must be within Absolute Maximum Ratings at all times
- (4) No missing codes
- (5) $\text{ADC_output} = \Sigma(4^n \text{ samples}) \gg n$, n = desired extra bits

7.18.2 DAC

7.18.2.1 Digital-to-Analog Converter (DAC) Characteristics

$T_c = 25^\circ\text{C}$, $V_{DD5} = 3.0\text{ V}$, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
General Parameters						
	Resolution		8			Bits
V _{DDS}	Supply voltage	Any load, any V _{REF} , pre-charge OFF, DAC charge-pump ON	1.8		3.8	V
		External Load ⁽⁴⁾ , any V _{REF} , pre-charge OFF, DAC charge-pump OFF	2.0		3.8	
		Any load, V _{REF} = DCOUPL, pre-charge ON	2.6		3.8	
F _{DAC}	Clock frequency	Buffer ON (recommended for external load)	16		250	kHz
		Buffer OFF (internal load)	16		1000	
	Voltage output settling time	V _{REF} = V _{DDS} , buffer OFF, internal load	13			1 / F _{DAC}
		V _{REF} = V _{DDS} , buffer ON, external capacitive load = 20 pF ⁽³⁾	13.8			
	External capacitive load		20		200	pF
	External resistive load		10			MΩ
	Short circuit current				400	μA
Z _{MAX}	Max output impedance Vref = V _{DDS} , buffer ON, CLK 250 kHz	V _{DDS} = 3.8 V, DAC charge-pump OFF	50.8			kΩ
		V _{DDS} = 3.0 V, DAC charge-pump ON	51.7			
		V _{DDS} = 3.0 V, DAC charge-pump OFF	53.2			
		V _{DDS} = 2.0 V, DAC charge-pump ON	48.7			
		V _{DDS} = 2.0 V, DAC charge-pump OFF	70.2			
		V _{DDS} = 1.8 V, DAC charge-pump ON	46.3			
		V _{DDS} = 1.8 V, DAC charge-pump OFF	88.9			
Internal Load - Continuous Time Comparator / Low Power Clocked Comparator						
DNL	Differential nonlinearity	V _{REF} = V _{DDS} , load = Continuous Time Comparator or Low Power Clocked Comparator F _{DAC} = 250 kHz	±1			LSB ⁽¹⁾
	Differential nonlinearity	V _{REF} = V _{DDS} , load = Continuous Time Comparator or Low Power Clocked Comparator F _{DAC} = 16 kHz	±1.2			

7.18.2.1 Digital-to-Analog Converter (DAC) Characteristics (continued)

$T_c = 25\text{ }^{\circ}\text{C}$, $V_{DD5} = 3.0\text{ V}$, unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Offset error ⁽²⁾ Load = Continuous Time Comparator	$V_{REF} = V_{DD5} = 3.8\text{ V}$		±0.64		LSB ⁽¹⁾
	$V_{REF} = V_{DD5} = 3.0\text{ V}$		±0.81		
	$V_{REF} = V_{DD5} = 1.8\text{ V}$		±1.27		
	$V_{REF} = \text{DCOUP}, \text{pre-charge ON}$		±3.43		
	$V_{REF} = \text{DCOUP}, \text{pre-charge OFF}$		±2.88		
	$V_{REF} = \text{ADCREf}$		±2.37		
Offset error ⁽²⁾ Load = Low Power Clocked Comparator	$V_{REF} = V_{DD5} = 3.8\text{ V}$		±0.78		LSB ⁽¹⁾
	$V_{REF} = V_{DD5} = 3.0\text{ V}$		±0.77		
	$V_{REF} = V_{DD5} = 1.8\text{ V}$		±3.46		
	$V_{REF} = \text{DCOUP}, \text{pre-charge ON}$		±3.44		
	$V_{REF} = \text{DCOUP}, \text{pre-charge OFF}$		±4.70		
	$V_{REF} = \text{ADCREf}$		±4.11		
Max code output voltage variation ⁽²⁾ Load = Continuous Time Comparator	$V_{REF} = V_{DD5} = 3.8\text{ V}$		±1.53		LSB ⁽¹⁾
	$V_{REF} = V_{DD5} = 3.0\text{ V}$		±1.71		
	$V_{REF} = V_{DD5} = 1.8\text{ V}$		±2.10		
	$V_{REF} = \text{DCOUP}, \text{pre-charge ON}$		±6.00		
	$V_{REF} = \text{DCOUP}, \text{pre-charge OFF}$		±3.85		
	$V_{REF} = \text{ADCREf}$		±5.84		
Max code output voltage variation ⁽²⁾ Load = Low Power Clocked Comparator	$V_{REF} = V_{DD5} = 3.8\text{ V}$		±2.92		LSB ⁽¹⁾
	$V_{REF} = V_{DD5} = 3.0\text{ V}$		±3.06		
	$V_{REF} = V_{DD5} = 1.8\text{ V}$		±3.91		
	$V_{REF} = \text{DCOUP}, \text{pre-charge ON}$		±7.84		
	$V_{REF} = \text{DCOUP}, \text{pre-charge OFF}$		±4.06		
	$V_{REF} = \text{ADCREf}$		±6.94		
Output voltage range ⁽²⁾ Load = Continuous Time Comparator	$V_{REF} = V_{DD5} = 3.8\text{ V}, \text{code } 1$		0.03		V
	$V_{REF} = V_{DD5} = 3.8\text{ V}, \text{code } 255$		3.62		
	$V_{REF} = V_{DD5} = 3.0\text{ V}, \text{code } 1$		0.02		
	$V_{REF} = V_{DD5} = 3.0\text{ V}, \text{code } 255$		2.86		
	$V_{REF} = V_{DD5} = 1.8\text{ V}, \text{code } 1$		0.01		
	$V_{REF} = V_{DD5} = 1.8\text{ V}, \text{code } 255$		1.71		
	$V_{REF} = \text{DCOUP}, \text{pre-charge OFF}, \text{code } 1$		0.01		
	$V_{REF} = \text{DCOUP}, \text{pre-charge OFF}, \text{code } 255$		1.21		
	$V_{REF} = \text{DCOUP}, \text{pre-charge ON}, \text{code } 1$		1.27		
	$V_{REF} = \text{DCOUP}, \text{pre-charge ON}, \text{code } 255$		2.46		
	$V_{REF} = \text{ADCREf}, \text{code } 1$		0.01		
	$V_{REF} = \text{ADCREf}, \text{code } 255$		1.41		
Output voltage range ⁽²⁾ Load = Low Power Clocked Comparator	$V_{REF} = V_{DD5} = 3.8\text{ V}, \text{code } 1$		0.03		V
	$V_{REF} = V_{DD5} = 3.8\text{ V}, \text{code } 255$		3.61		
	$V_{REF} = V_{DD5} = 3.0\text{ V}, \text{code } 1$		0.02		
	$V_{REF} = V_{DD5} = 3.0\text{ V}, \text{code } 255$		2.85		
	$V_{REF} = V_{DD5} = 1.8\text{ V}, \text{code } 1$		0.01		
	$V_{REF} = V_{DD5} = 1.8\text{ V}, \text{code } 255$		1.71		
	$V_{REF} = \text{DCOUP}, \text{pre-charge OFF}, \text{code } 1$		0.01		
	$V_{REF} = \text{DCOUP}, \text{pre-charge OFF}, \text{code } 255$		1.21		
	$V_{REF} = \text{DCOUP}, \text{pre-charge ON}, \text{code } 1$		1.27		
	$V_{REF} = \text{DCOUP}, \text{pre-charge ON}, \text{code } 255$		2.46		
	$V_{REF} = \text{ADCREf}, \text{code } 1$		0.01		
	$V_{REF} = \text{ADCREf}, \text{code } 255$		1.41		

7.18.2.1 Digital-to-Analog Converter (DAC) Characteristics (continued)

$T_c = 25\text{ }^{\circ}\text{C}$, $V_{DD5} = 3.0\text{ V}$, unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
External Load (Keysight 34401A Multimeter)						
INL	Integral nonlinearity	$V_{REF} = V_{DD5}$, $F_{DAC} = 250\text{ kHz}$		± 1		LSB ⁽¹⁾
		$V_{REF} = DCOUPL$, $F_{DAC} = 250\text{ kHz}$		± 1		
		$V_{REF} = ADCREF$, $F_{DAC} = 250\text{ kHz}$		± 1		
DNL	Differential nonlinearity	$V_{REF} = V_{DD5}$, $F_{DAC} = 250\text{ kHz}$		± 1		LSB ⁽¹⁾
	Offset error	$V_{REF} = V_{DD5} = 3.8\text{ V}$		± 0.20		LSB ⁽¹⁾
		$V_{REF} = V_{DD5} = 3.0\text{ V}$		± 0.25		
		$V_{REF} = V_{DD5} = 1.8\text{ V}$		± 0.45		
		$V_{REF} = DCOUPL$, pre-charge ON		± 1.55		
		$V_{REF} = DCOUPL$, pre-charge OFF		± 1.30		
		$V_{REF} = ADCREF$		± 1.10		
	Max code output voltage variation	$V_{REF} = V_{DD5} = 3.8\text{ V}$		± 0.60		LSB ⁽¹⁾
		$V_{REF} = V_{DD5} = 3.0\text{ V}$		± 0.55		
		$V_{REF} = V_{DD5} = 1.8\text{ V}$		± 0.60		
		$V_{REF} = DCOUPL$, pre-charge ON		± 3.45		
		$V_{REF} = DCOUPL$, pre-charge OFF		± 2.10		
		$V_{REF} = ADCREF$		± 1.90		
	Output voltage range Load = Low Power Clocked Comparator	$V_{REF} = V_{DD5} = 3.8\text{ V}$, code 1		0.03		V
		$V_{REF} = V_{DD5} = 3.8\text{ V}$, code 255		3.61		
		$V_{REF} = V_{DD5} = 3.0\text{ V}$, code 1		0.02		
		$V_{REF} = V_{DD5} = 3.0\text{ V}$, code 255		2.85		
		$V_{REF} = V_{DD5} = 1.8\text{ V}$, code 1		0.02		
		$V_{REF} = V_{DD5} = 1.8\text{ V}$, code 255		1.71		
		$V_{REF} = DCOUPL$, pre-charge OFF, code 1		0.02		
		$V_{REF} = DCOUPL$, pre-charge OFF, code 255		1.20		
		$V_{REF} = DCOUPL$, pre-charge ON, code 1		1.27		
		$V_{REF} = DCOUPL$, pre-charge ON, code 255		2.46		
		$V_{REF} = ADCREF$, code 1		0.02		
		$V_{REF} = ADCREF$, code 255		1.42		

(1) 1 LSB ($V_{REF} = 3.8\text{ V}/3.0\text{ V}/1.8\text{ V}/DCOUP/ADCREF$) = 14.10 mV/11.13 mV/6.68 mV/4.67 mV/5.48 mV

(2) Includes comparator offset

(3) A load > 20 pF will increase the settling time

(4) Keysight 34401A Multimeter

7.18.3 Temperature and Battery Monitor

7.18.3.1 Temperature Sensor

Measured on a Texas Instruments reference design with $T_c = 25\text{ }^{\circ}\text{C}$, $V_{\text{DD}} = 3.0\text{ V}$, unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Resolution			2		$^{\circ}\text{C}$
Accuracy	$-40\text{ }^{\circ}\text{C}$ to $0\text{ }^{\circ}\text{C}$		± 4.0		$^{\circ}\text{C}$
Accuracy	$0\text{ }^{\circ}\text{C}$ to $105\text{ }^{\circ}\text{C}$		± 2.5		$^{\circ}\text{C}$
Supply voltage coefficient ⁽¹⁾			3.9		$^{\circ}\text{C}/\text{V}$

(1) The temperature sensor is automatically compensated for V_{DD} variation when using the TI-provided driver.

7.18.3.2 Battery Monitor

Measured on a Texas Instruments reference design with $T_c = 25\text{ }^{\circ}\text{C}$, unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Resolution			25		mV
Range		1.8		3.8	V
Integral nonlinearity (max)			23		mV
Accuracy	$V_{\text{DD}} = 3.0\text{ V}$		22.5		mV
Offset error			-32		mV
Gain error			-1		%

7.18.4 Comparator

7.18.4.1 Continuous Time Comparator

$T_c = 25\text{ }^{\circ}\text{C}$, $V_{\text{DD}} = 3.0\text{ V}$, unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage range ⁽¹⁾		0		V_{DD}	V
Offset	Measured at $V_{\text{DD}} / 2$		± 5		mV
Decision time	Step from -10 mV to 10 mV		0.78		μs
Current consumption	Internal reference		9.2		μA

(1) The input voltages can be generated externally and connected throughout I/Os or an internal reference voltage can be generated using the DAC

7.18.5 GPIO

7.18.5.1 GPIO DC Characteristics

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
T_A = 25 °C, V_{DDs} = 1.8 V					
GPIO VOH at 8 mA load	IOCURR = 2, high-drive GPIOs only		1.56		V
GPIO VOL at 8 mA load	IOCURR = 2, high-drive GPIOs only		0.24		V
GPIO VOH at 4 mA load	IOCURR = 1		1.59		V
GPIO VOL at 4 mA load	IOCURR = 1		0.21		V
GPIO pullup current	Input mode, pullup enabled, Vpad = 0 V		73		μA
GPIO pulldown current	Input mode, pulldown enabled, Vpad = VDDs		19		μA
GPIO low-to-high input transition, with hysteresis	IH = 1, transition voltage for input read as 0 → 1		1.08		V
GPIO high-to-low input transition, with hysteresis	IH = 1, transition voltage for input read as 1 → 0		0.73		V
GPIO input hysteresis	IH = 1, difference between 0 → 1 and 1 → 0 points		0.35		V
T_A = 25 °C, V_{DDs} = 3.0 V					
GPIO VOH at 8 mA load	IOCURR = 2, high-drive GPIOs only		2.59		V
GPIO VOL at 8 mA load	IOCURR = 2, high-drive GPIOs only		0.42		V
GPIO VOH at 4 mA load	IOCURR = 1		2.63		V
GPIO VOL at 4 mA load	IOCURR = 1		0.40		V
T_A = 25 °C, V_{DDs} = 3.8 V					
GPIO pullup current	Input mode, pullup enabled, Vpad = 0 V		282		μA
GPIO pulldown current	Input mode, pulldown enabled, Vpad = VDDs		110		μA
GPIO low-to-high input transition, with hysteresis	IH = 1, transition voltage for input read as 0 → 1		1.97		V
GPIO high-to-low input transition, with hysteresis	IH = 1, transition voltage for input read as 1 → 0		1.55		V
GPIO input hysteresis	IH = 1, difference between 0 → 1 and 1 → 0 points		0.42		V
T_A = 25 °C					
VIH	Lowest GPIO input voltage reliably interpreted as a <i>High</i>	0.8*V _{DDs}			V
VIL	Highest GPIO input voltage reliably interpreted as a <i>Low</i>		0.2*V _{DDs}		V

7.19 Typical Characteristics

All measurements in this section are done with $T_c = 25^\circ\text{C}$ and $V_{\text{DD}} = 3.0\text{V}$, unless otherwise noted. See *Recommended Operating Conditions*, [Section 7.3](#), for device limits. Values exceeding these limits are for reference only.

7.19.1 MCU Current

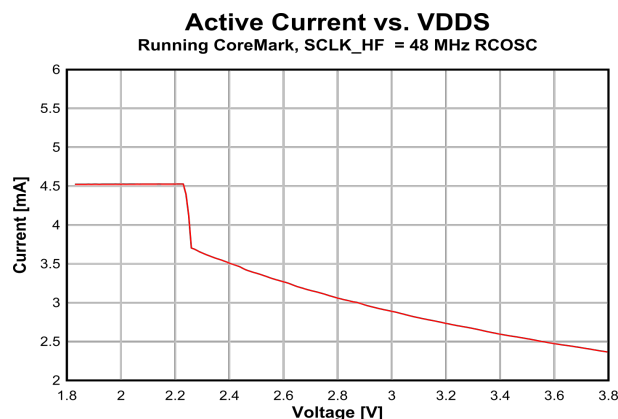


Figure 7-4. Active Mode (MCU) Current vs Supply Voltage (VDD)

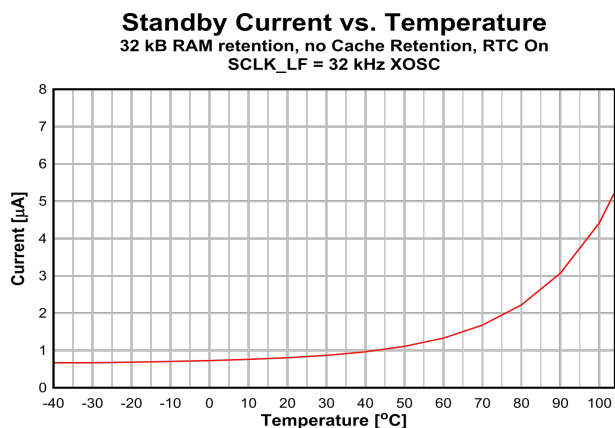


Figure 7-5. Standby Mode (MCU) Current vs Temperature

7.19.2 RX Current

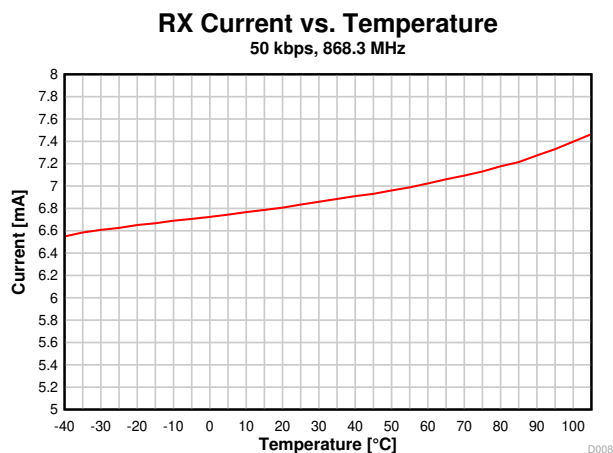


Figure 7-6. RX Current vs Temperature (50kbps, 868.3MHz)

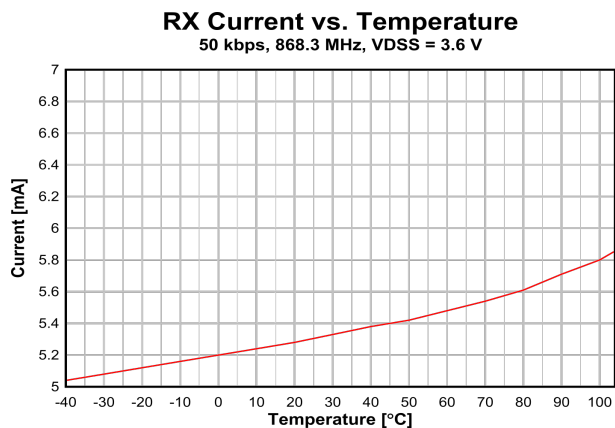


Figure 7-7. RX Current vs Temperature (50kbps, 868.3MHz, VDD = 3.6)

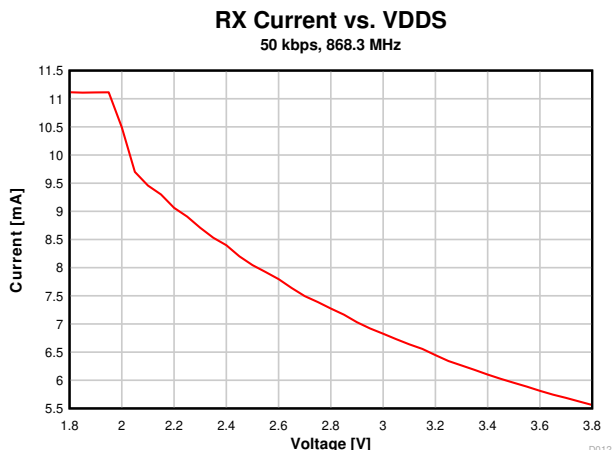


Figure 7-8. RX Current vs Supply Voltage (VDD5) (50kbps, 868.3MHz)

7.19.3 TX Current

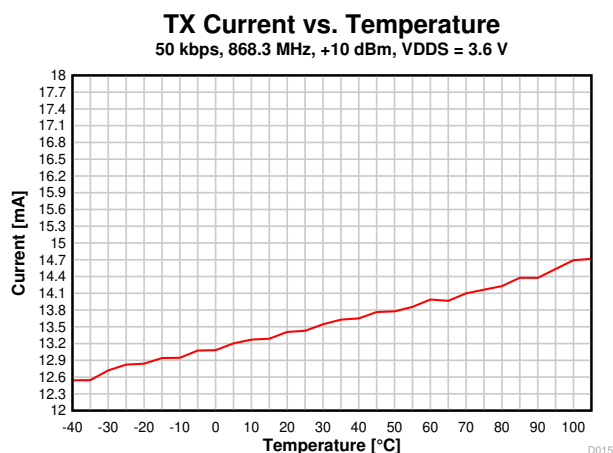


Figure 7-9. TX Current vs Temperature (50kbps, 868.3MHz, VDD5 = 3.6V)

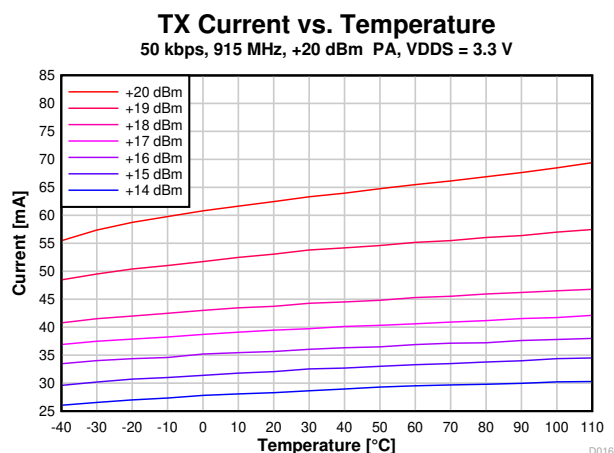


Figure 7-10. TX Current vs Temperature (50kbps, 915MHz, VDD5 = 3.3V)

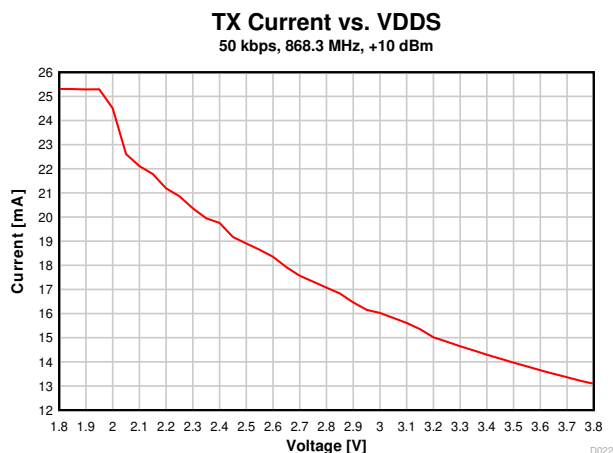


Figure 7-11. TX Current vs Supply Voltage (VDD5) (50 kbps, 868.3MHz)

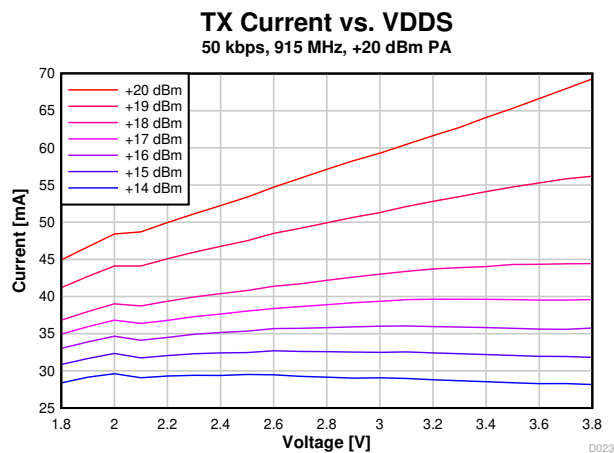


Figure 7-12. TX Current vs Supply Voltage (VDD5) (50 kbps, 915MHz)

Table 7-2 shows typical TX current and output power for different output power settings.

Table 7-1. Typical TX Current and Output Power, high power PA (915MHz, VDDS = 3.3V)

CC1311P3 at 915MHz, VDDS = 3.3V (Measured on CC1311-P3EM-7XD7793-PA915)			
txPower	TX Power Setting (SmartRF Studio)	Typical Output Power [dBm]	Typical Current Consumption [mA]
0x1B8ED2	20	20.6	64.9
0x448CF	19	19.5	55.4
0x48022	18	18.0	46.0
0x2661C	17	17.1	41.5
0x5618	16	16.2	37.6
0x4812	15	15.2	33.9
0x380D	14	14.0	30.2

Table 7-2. Typical TX Current and Output Power (868MHz, VDDS = 3.0V)

CC1311P3 at 868MHz, VDDS = 3.0V (Measured on CC1311-P3EM-7XD7793-PA915)			
txPower	TX Power Setting (SmartRF Studio)	Typical Output Power [dBm]	Typical Current Consumption [mA]
0x013F ¹	14	13.8	30.0
0xB224	12.5	12.2	21.5
0x895E	12	11.8	20.3
0x669A	11	10.8	18.1
0x3E92	10	9.8	16.4
0x3EDC	9	8.9	15.5
0x2CD8	8	8.1	14.5
0x26D4	7	7.0	13.3
0x20D1	6	5.8	12.2
0x1CCE	5	4.4	10.9
0x16CD	4	3.7	10.5
0x14CB	3	2.2	9.7
0x12CA	2	1.5	9.2
0x12C9	1	0.6	8.8
0x10C8	0	-0.5	8.3
0xAC4	-5	-7.3	6.5
0xAC2	-10	-13.1	5.6
0x6C1	-15	-18.3	5.2
0x4C0	-20	-22.6	4.9

¹ Boost mode enabled. VDDR regulated to 1.95V.

7.19.4 RX Performance

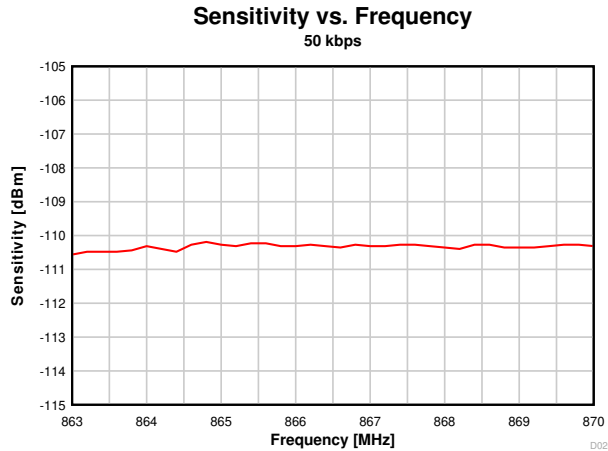


Figure 7-13. Sensitivity vs Frequency (50kbps, 868MHz)

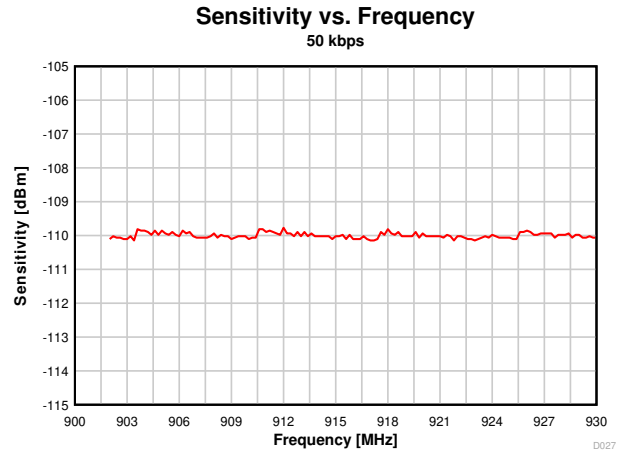


Figure 7-14. Sensitivity vs Frequency (50kbps, 915MHz)

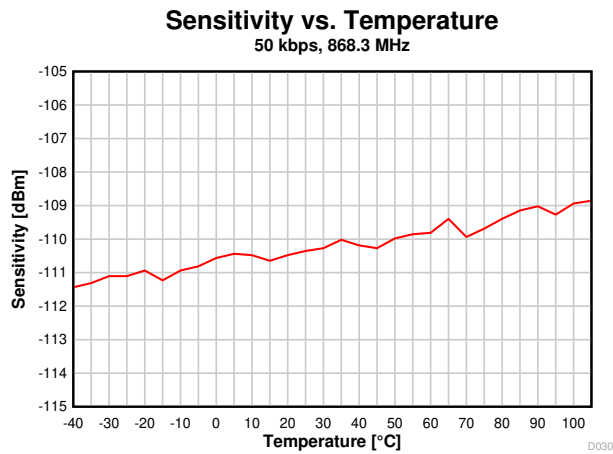


Figure 7-15. Sensitivity vs Temperature (50kbps, 868.3MHz)

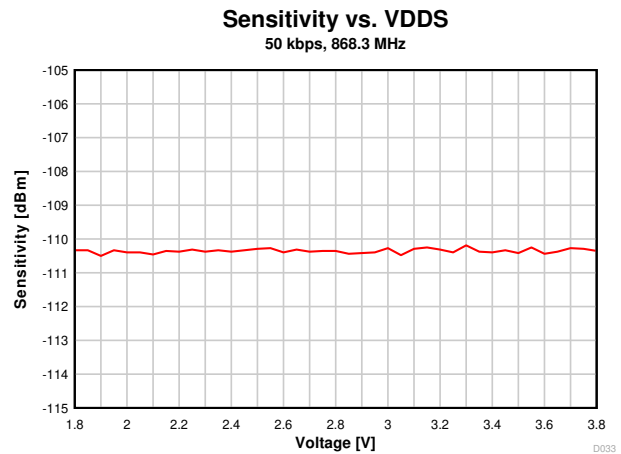


Figure 7-16. Sensitivity vs Supply Voltage (VDDS) (50kbps, 868.3MHz)

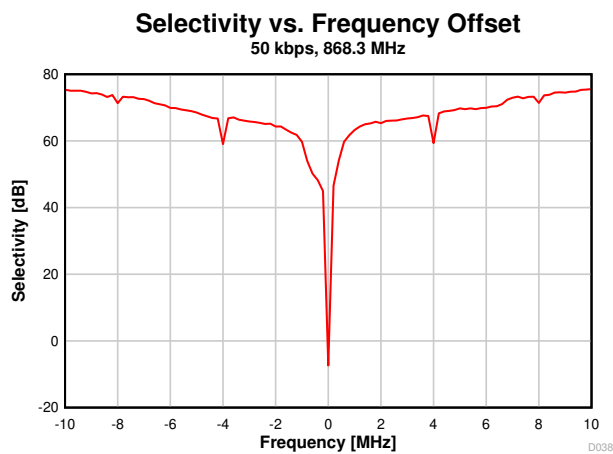


Figure 7-17. Selectivity vs Frequency Offset (50kbps, 868.3MHz)

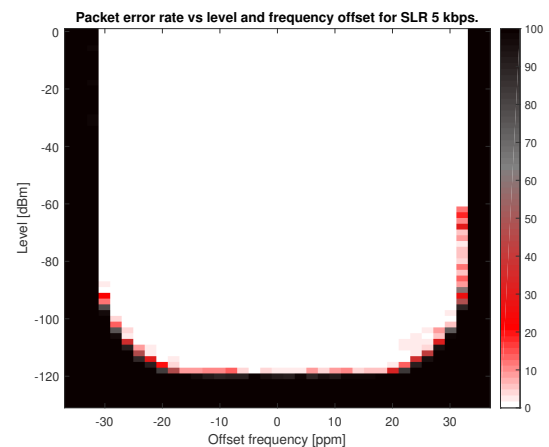


Figure 7-18. PER vs Level vs Frequency (SimpleLink™ Long Range 5kbps, 868MHz)

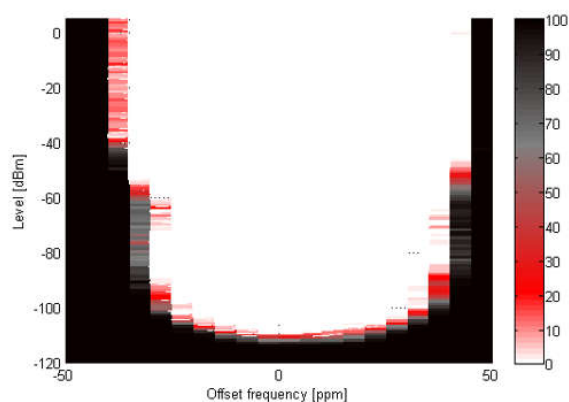


Figure 7-19. 802.15.4, 50kbps, ± 25 kHz Deviation, 2-GFSK, 100kHz RX Bandwidth

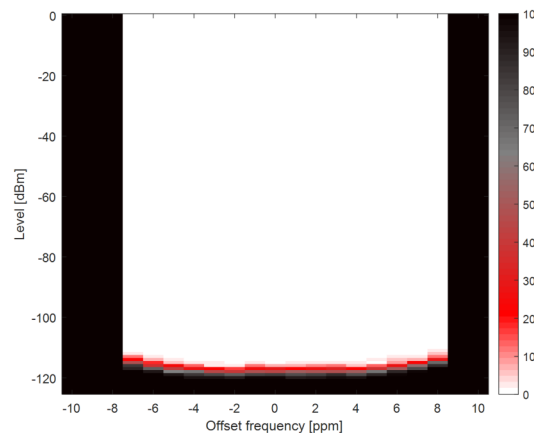


Figure 7-20. Narrowband, 9.6kbps ± 2.4 kHz Deviation, 2-GFSK, 868MHz, 17.1kHz RX Bandwidth

7.19.5 TX Performance

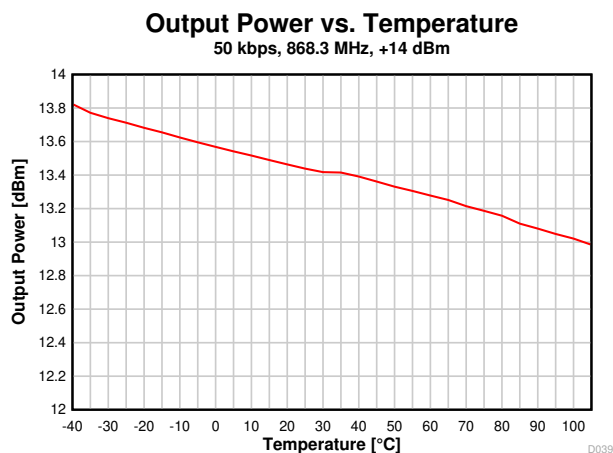


Figure 7-21. Output Power vs Temperature (50kbps, 868.3MHz)

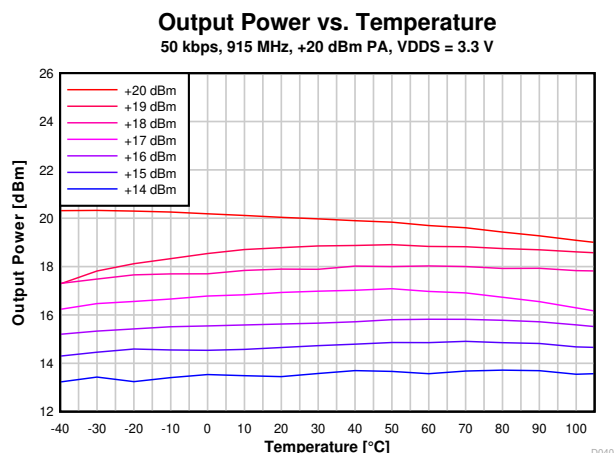


Figure 7-22. Output Power vs Temperature (50kbps, 915MHz)

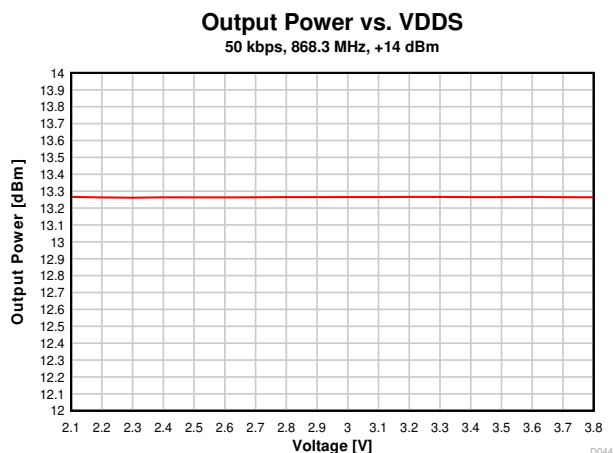


Figure 7-23. Output Power vs Supply Voltage (VDD5) (50kbps, 868.3MHz)

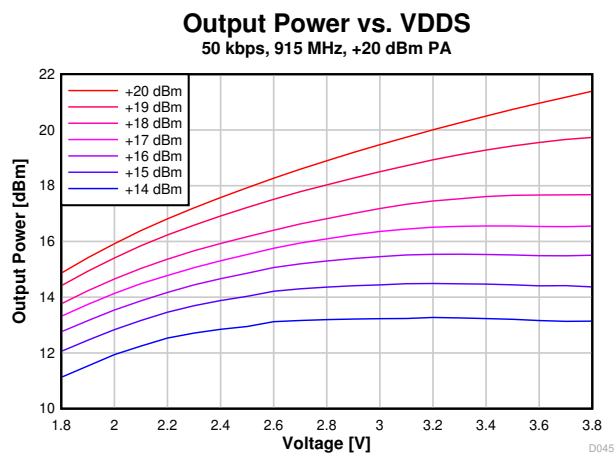


Figure 7-24. Output Power vs Supply Voltage (VDD5) (50kbps, 915MHz)

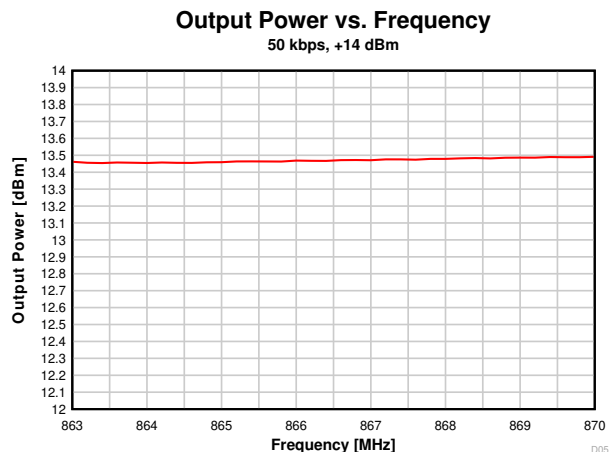


Figure 7-25. Output Power vs Frequency (50kbps, 868MHz)

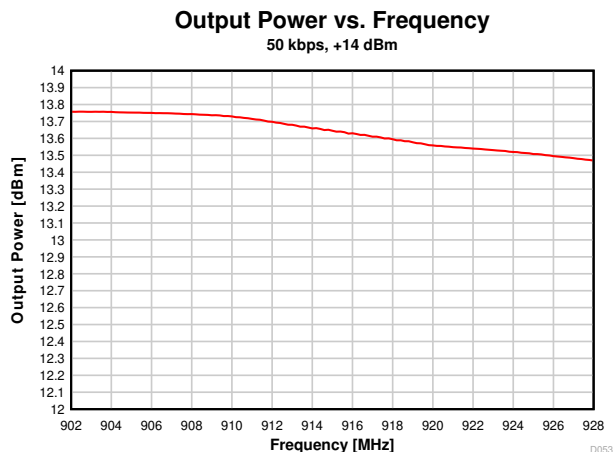


Figure 7-26. Output Power vs Frequency (50kbps, 915MHz)

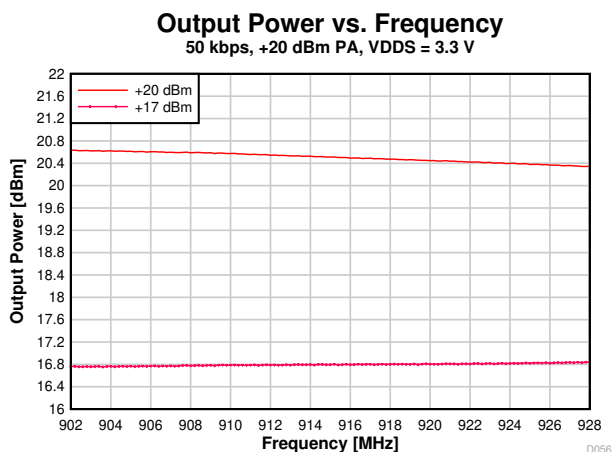


Figure 7-27. Output Power vs Frequency (50kbps, 915MHz, VDDS = 3.3V)

7.19.6 ADC Performance

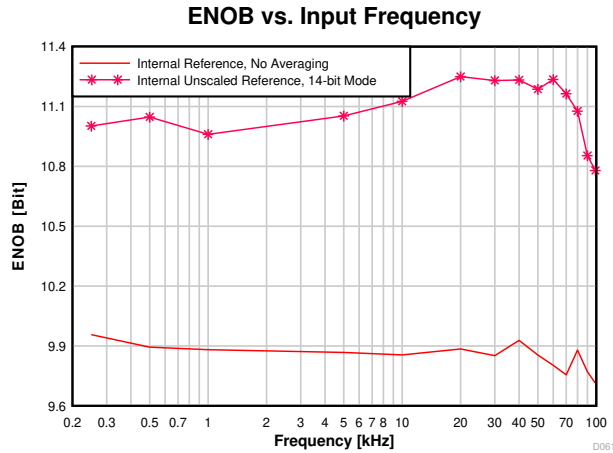


Figure 7-28. ENOB vs Input Frequency

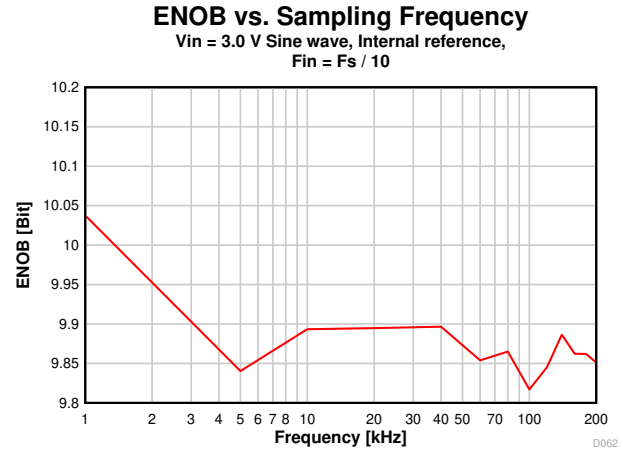


Figure 7-29. ENOB vs Sampling Frequency

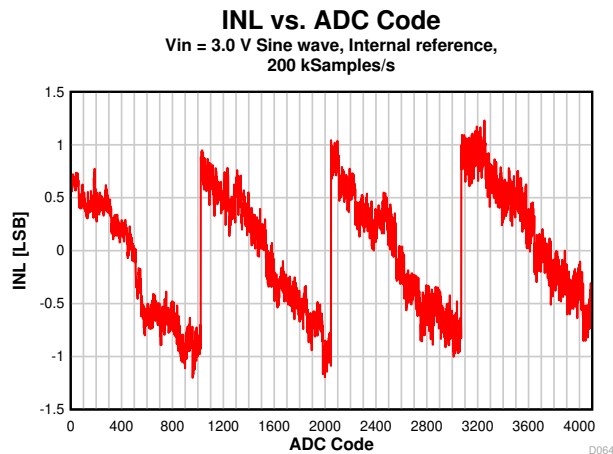


Figure 7-30. INL vs ADC Code

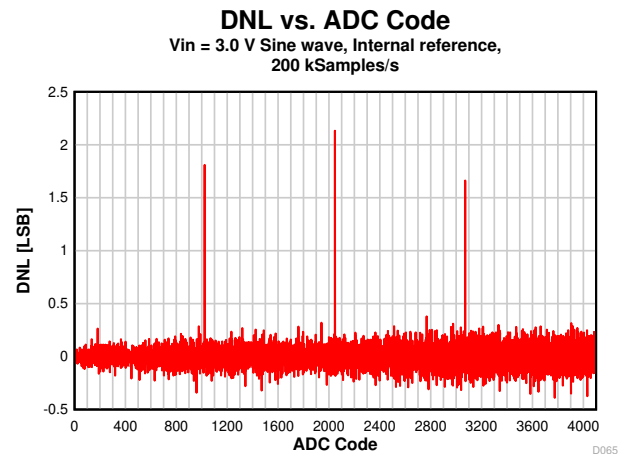


Figure 7-31. DNL vs ADC Code

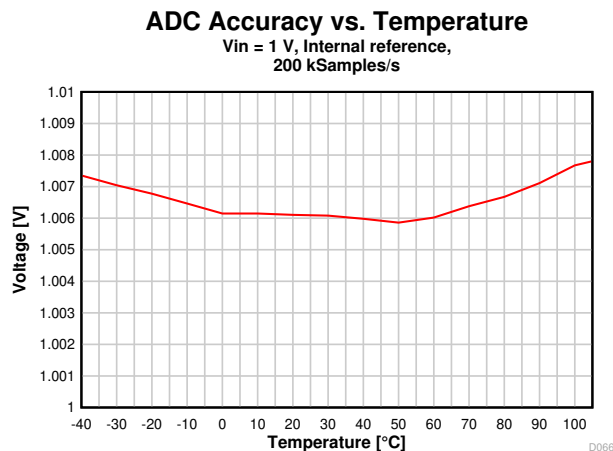


Figure 7-32. ADC Accuracy vs Temperature

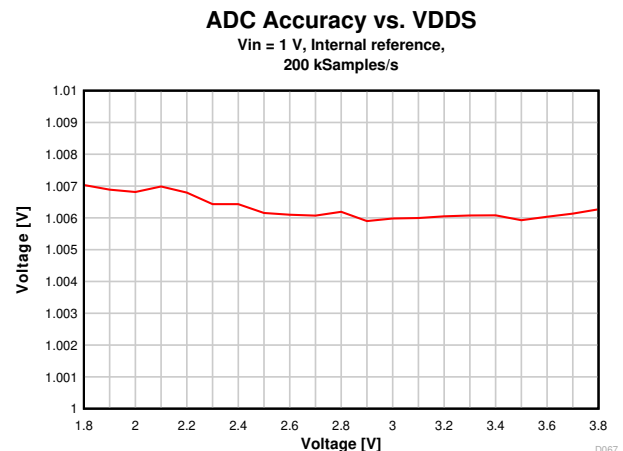


Figure 7-33. ADC Accuracy vs Supply Voltage (VDD)

8 Detailed Description

8.1 Overview

[Section 4](#) shows the core modules of the CC1311P3 device.

8.2 System CPU

The CC1311P3 SimpleLink™ Wireless MCU contains an Arm® Cortex®-M4 system CPU, which runs the application and the higher layers of radio protocol stacks.

The system CPU is the foundation of a high-performance, low-cost platform that meets the system requirements of minimal memory implementation, and low-power consumption, while delivering outstanding computational performance and exceptional system response to interrupts.

Its features include the following:

- ARMv7-M architecture optimized for small-footprint embedded applications
- Arm Thumb®-2 mixed 16- and 32-bit instruction set delivers the high performance expected of a 32-bit Arm core in a compact memory size
- Fast code execution permits increased sleep mode time
- Deterministic, high-performance interrupt handling for time-critical applications
- Single-cycle multiply instruction and hardware divide
- Hardware division and fast digital-signal-processing oriented multiply accumulate
- Saturating arithmetic for signal processing
- Full debug with data matching for watchpoint generation
 - Data Watchpoint and Trace Unit (DWT)
 - JTAG Debug Access Port (DAP)
 - Flash Patch and Breakpoint Unit (FPB)
- Trace support reduces the number of pins required for debugging and tracing
 - Instrumentation Trace Macrocell Unit (ITM)
 - Trace Port Interface Unit (TPIU) with asynchronous serial wire output (SWO)
- Optimized for single-cycle flash memory access
- Tightly connected to 8KB 4-way random replacement cache for minimal active power consumption and wait states
- Ultra-low-power consumption with integrated sleep modes
- 48MHz operation
- 1.25 DMIPS per MHz

8.3 Radio (RF Core)

The RF Core is a highly flexible and future proof radio module which contains an Arm Cortex-M0 processor that interfaces the analog RF and base-band circuitry, handles data to and from the system CPU side, and assembles the information bits in a given packet structure. The RF core offers a high level, command-based API to the main CPU that configurations and data are passed through. The Arm Cortex-M0 processor is not programmable by customers and is interfaced through the TI-provided RF driver that is included with the SimpleLink Software Development Kit (SDK).

The RF core can autonomously handle the time-critical aspects of the radio protocols, thus offloading the main CPU, which reduces power and leaves more resources for the user application. Several signals are also available to control external circuitry such as RF switches or range extenders autonomously.

The various physical layer radio formats are partly built as a software defined radio where the radio behavior is either defined by radio ROM contents or by non-ROM radio formats delivered in form of firmware patches with the SimpleLink SDKs. This allows the radio platform to be updated for support of future versions of standards even with over-the-air (OTA) updates while still using the same silicon.

Note

Not all combinations of features, frequencies, data rates, and modulation formats described in this chapter are supported. Over time, TI can enable new physical radio formats (PHYs) for the device and provides performance numbers for selected PHYs in the data sheet. Supported radio formats for a specific device, including optimized settings to use with the TI RF driver, are included in the [SmartRF Studio](#) tool with performance numbers of selected formats found in [Section 7](#).

8.3.1 Proprietary Radio Formats

The CC1311P3 radio can support a wide range of physical radio formats through a set of hardware peripherals combined with firmware available in the device ROM, covering various customer needs for optimizing towards parameters such as speed or sensitivity. This allows great flexibility in tuning the radio both to work with legacy protocols as well as customizing the behavior for specific application needs.

Table 8-1 gives a simplified overview of features of the various radio formats available in ROM. Other radio formats may be available in the form of radio firmware patches or programs through the Software Development Kit (SDK) and may combine features in a different manner, as well as add other features.

Table 8-1. Feature Support

Feature	Main 2-(G)FSK Mode	High Data Rates	Low Data Rates	SimpleLink™ Long Range
Programmable preamble, sync word and CRC	Yes	Yes	Yes	No
Programmable receive bandwidth	Yes	Yes	Yes (down to 4kHz)	Yes
Data / Symbol rate ⁽³⁾	20 to 1000 kbps	≤ 2 Msps	≤ 100 kbps	≤ 20 kbps
Modulation format	2-(G)FSK	2-(G)FSK 4-(G)FSK	2-(G)FSK 4-(G)FSK	2-(G)FSK
Dual Sync Word	Yes	Yes	No	No
Carrier Sense ⁽¹⁾ ⁽²⁾	Yes	No	No	No
Preamble Detection ⁽²⁾	Yes	Yes	Yes	No
Data Whitening	Yes	Yes	Yes	Yes
Digital RSSI	Yes	Yes	Yes	Yes
CRC filtering	Yes	Yes	Yes	Yes
Direct-sequence spread spectrum (DSSS)	No	No	No	1:2 1:4 1:8
Forward error correction (FEC)	No	No	No	Yes
Link Quality Indicator (LQI)	Yes	Yes	Yes	Yes

- (1) Carrier Sense can be used to implement HW-controlled listen-before-talk (LBT) and Clear Channel Assessment (CCA) for compliance with such requirements in regulatory standards. This is available through the CMD_PROP_CS radio API.
- (2) Carrier Sense and Preamble Detection can be used to implement sniff modes where the radio is duty cycled to save power.
- (3) Data rates are only indicative. Data rates outside this range may also be supported. For some specific combinations of settings, a smaller range might be supported.

8.4 Memory

The up to 352KB nonvolatile (Flash) memory provides storage for code and data. The flash memory is in-system programmable and erasable. The last flash memory sector must contain a Customer Configuration section (CCFG) that is used by boot ROM and TI provided drivers to configure the device. This configuration is done through the `ccfg.c` source file that is included in all TI provided examples.

The ultra-low leakage system static RAM (SRAM) is a single 32KB block and can be used for both storage of data and execution of code. Retention of SRAM contents in Standby power mode is enabled by default and included in Standby mode power consumption numbers.

To improve code execution speed and lower power when executing code from nonvolatile memory, a 4-way nonassociative 8KB cache is enabled by default to cache and prefetch instructions read by the system CPU. The cache can be used as a general-purpose RAM by enabling this feature in the Customer Configuration Area (CCFG).

The ROM contains a serial (SPI and UART) bootloader that can be used for initial programming of the device.

8.5 Cryptography

The CC1311P3 device comes with a wide set of cryptography-related hardware accelerators, reducing code footprint and execution time for cryptographic operations. It also has the benefit of being lower power and improves availability and responsiveness of the system because the cryptography operations run in a background hardware thread.

The hardware accelerator modules are:

- **True Random Number Generator (TRNG)** module provides a true, nondeterministic noise source for the purpose of generating keys, initialization vectors (IVs), and other random number requirements. The TRNG is built on 24 ring oscillators that create unpredictable output to feed a complex nonlinear-combinatorial circuit.
- **Advanced Encryption Standard (AES)** with 128 bit key lengths

Together with the hardware accelerator module, a large selection of open-source cryptography libraries provided with the Software Development Kit (SDK), this allows for secure and future proof IoT applications to be easily built on top of the platform. The TI provided cryptography drivers are:

- **Key Agreement Schemes**
 - Elliptic curve Diffie–Hellman with static or ephemeral keys (ECDH and ECDHE)
- **Signature Generation**
 - Elliptic curve Diffie–Hellman Digital Signature Algorithm (ECDSA)
- **Curve Support**
 - Short Weierstrass form (full hardware support), such as:
 - NIST-P256
 - Montgomery form (hardware support for multiplication), such as:
 - Curve25519
- **Hash**
 - SHA256
- **MACs**
 - HMAC with SHA256
 - AES CBC-MAC
- **Block ciphers**
 - AESECB
 - AESCBC
 - AESCTR
- **Authenticated Encryption**
 - AESCCM
- **Random number generation**
 - True Random Number Generator
 - AES CTR DRBG

8.6 Timers

A large selection of timers are available as part of the CC1311P3 device. These timers are:

- **Real-Time Clock (RTC)**

A 70-bit 3-channel timer running on the 32kHz low frequency system clock (SCLK_LF)

This timer is available in all power modes except Shutdown. The timer can be calibrated to compensate for frequency drift when using the LF RCOSC as the low frequency system clock. If an external LF clock with frequency different from 32.768kHz is used, the RTC tick speed can be adjusted to compensate for this. When using TI-RTOS, the RTC is used as the base timer in the operating system and should thus only be accessed through the kernel APIs such as the Clock module. By default, the RTC halts when a debugger halts the device.

- **General Purpose Timers (GPTIMER)**

The four flexible GPTIMERS can be used as either 4× 32 bit timers or 8× 16 bit timers, all running on up to 48MHz. Each of the 16- or 32-bit timers support a wide range of features such as one-shot or periodic counting, pulse width modulation (PWM), time counting between edges and edge counting. The inputs and outputs of the timer are connected to the device event fabric, which allows the timers to interact with signals such as GPIO inputs, other timers, DMA and ADC. The GPTIMERS are available in Active and Idle power modes.

- **Radio Timer**

A multichannel 32-bit timer running at 4MHz is available as part of the device radio. The radio timer is typically used as the timing base in wireless network communication using the 32-bit timing word as the network time. The radio timer is synchronized with the RTC by using a dedicated radio API when the device radio is turned on or off. This ensures that for a network stack, the radio timer seems to always be running when the radio is enabled. The radio timer is in most cases used indirectly through the trigger time fields in the radio APIs and should only be used when running the accurate 48MHz high frequency crystal is the source of SCLK_HF.

- **Watchdog timer**

The watchdog timer is used to regain control if the system operates incorrectly due to software errors. It is typically used to generate an interrupt to and reset of the device for the case where periodic monitoring of the system components and tasks fails to verify proper functionality. The watchdog timer runs on a 1.5MHz clock rate and cannot be stopped once enabled. The watchdog timer pauses to run in Standby power mode and when a debugger halts the device.

8.7 Serial Peripherals and I/O

The SSI is a synchronous serial interface that is compatible with SPI, MICROWIRE, and TI's synchronous serial interfaces. The SSI support both SPI master and slave up to 4MHz. The SSI module support configurable phase and polarity.

The UART implement universal asynchronous receiver and transmitter functions. It support flexible baud-rate generation up to a maximum of 3Mbps.

The I²S interface is used to handle digital audio and can also be used to interface pulse-density modulation microphones (PDM).

The I²C interface is also used to communicate with devices compatible with the I²C standard. The I²C interface can handle 100kHz and 400kHz operation, and can serve as both master and slave.

The I/O controller (IOC) controls the digital I/O pins and contains multiplexer circuitry to allow a set of peripherals to be assigned to I/O pins in a flexible manner. All digital I/Os are interrupt and wake-up capable, have a programmable pullup and pulldown function, and can generate an interrupt on a negative or positive edge (configurable). When configured as an output, pins can function as either push-pull or open-drain. Five GPIOs have high-drive capabilities, which are marked in **bold** in [Section 6](#). All digital peripherals can be connected to any digital pin on the device.

For more information, see the [CC13x1x3, CC26x1x3 SimpleLink™ Wireless MCU Technical Reference Manual](#).

8.8 Battery and Temperature Monitor

A combined temperature and battery voltage monitor is available in the CC1311P3 device. The battery and temperature monitor allows an application to continuously monitor on-chip temperature and supply voltage and respond to changes in environmental conditions as needed. The module contains window comparators to interrupt the system CPU when temperature or supply voltage go outside defined windows. These events can also be used to wake up the device from Standby mode through the Always-On (AON) event fabric.

8.9 Voltage Supply Domains

The CC1311P3 device can interface to two or three different voltage domains depending on the package type. On-chip level converters ensure correct operation as long as the signal voltage on each input/output pin is set with respect to the corresponding supply pin (VDDS, VDDS2, or VDDS3). [Pin Function to VDDS Mapping Table](#) lists the pin-to-VDDS mapping.

Table 8-2. Pin Function to VDDS Mapping Table

	Package	
	VQFN 7 × 7 (RGZ)	VQFN 5 × 5 (RKP)
VDDS ⁽¹⁾	DIO 23–30 Reset_N	DIO 15–22 Reset_N
VDDS2	DIO 1–11	DIO 1–9
VDDS3	DIO 12–22 JTAG_TCKC JTAG_TMSC	DIO 10–14 JTAG_TCKC JTAG_TMSC

(1) The VDDS_DCDC pin must always be connected to the same voltage as the VDDS pin.

8.10 μDMA

The device includes a direct memory access (μDMA) controller. The μDMA controller provides a way to offload data-transfer tasks from the system CPU, thus allowing for more efficient use of the processor and the available bus bandwidth. The μDMA controller can perform a transfer between memory and peripherals. The μDMA controller has dedicated channels for each supported on-chip module and can be programmed to automatically perform transfers between peripherals and memory when the peripheral is ready to transfer more data.

Some features of the μDMA controller include the following (this is not an exhaustive list):

- Highly flexible and configurable channel operation of up to 32 channels

- Transfer modes: memory-to-memory, memory-to-peripheral, peripheral-to-memory, and peripheral-to-peripheral
- Data sizes of 8, 16, and 32 bits
- Ping-pong mode for continuous streaming of data

8.11 Debug

The on-chip debug support is done through a dedicated cJTAG (IEEE 1149.7) or JTAG (IEEE 1149.1) interface. The device boots by default into cJTAG mode and must be reconfigured to use 4-pin JTAG.

8.12 Power Management

To minimize power consumption, the CC1311P3 supports a number of power modes and power management features (see [Table 8-3](#)).

Table 8-3. Power Modes

MODE	SOFTWARE CONFIGURABLE POWER MODES				RESET PIN HELD
	ACTIVE	IDLE	STANDBY	SHUTDOWN	
CPU	Active	Off	Off	Off	Off
Flash	On	Available	Off	Off	Off
SRAM	On	On	Retention	Off	Off
Radio	Available	Available	Off	Off	Off
Supply System	On	On	Duty Cycled	Off	Off
Register and CPU retention	Full	Full	Partial	No	No
SRAM retention	Full	Full	Full	No	No
48MHz high-speed clock (SCLK_HF)	XOSC_HF or RCOSC_HF	XOSC_HF or RCOSC_HF	Off	Off	Off
32kHz low-speed clock (SCLK_LF)	XOSC_LF or RCOSC_LF	XOSC_LF or RCOSC_LF	XOSC_LF or RCOSC_LF	Off	Off
Peripherals	Available	Available	Off	Off	Off
Wake-up on RTC	Available	Available	Available	Off	Off
Wake-up on pin edge	Available	Available	Available	Available	Off
Wake-up on reset pin	On	On	On	On	On
Brownout detector (BOD)	On	On	Duty Cycled	Off	Off
Power-on reset (POR)	On	On	On	Off	Off
Watchdog timer (WDT)	Available	Available	Paused	Off	Off

In **Active** mode, the application system CPU is actively executing code. Active mode provides normal operation of the processor and all of the peripherals that are currently enabled. The system clock can be any available clock source (see [Table 8-3](#)).

In **Idle** mode, all active peripherals can be clocked, but the Application CPU core and memory are not clocked and no code is executed. Any interrupt event brings the processor back into active mode.

In **Standby** mode, only the always-on (AON) domain is active. An external wake-up event or RTC event is required to bring the device back to active mode. MCU peripherals with retention do not need to be reconfigured when waking up again, and the CPU continues execution from where it went into standby mode. All GPIOs are latched in standby mode.

In **Shutdown** mode, the device is entirely turned off (including the AON domain), and the I/Os are latched with the value they had before entering shutdown mode. A change of state on any I/O pin defined as a *wake from shutdown pin* wakes up the device and functions as a reset trigger. The CPU can differentiate between reset in this way and reset-by-reset pin or power-on reset by reading the reset status register. The only state retained in this mode is the latched I/O state and the flash memory contents.

Note

The power, RF and clock management for the CC1311P3 device require specific configuration and handling by software for optimized performance. This configuration and handling is implemented in the TI-provided drivers that are part of the CC1311P3 software development kit (SDK). Therefore, TI highly recommends using this software framework for all application development on the device. The complete [SDK](#) with TI-RTOS (optional), device drivers, and examples are offered free of charge in source code.

8.13 Clock Systems

The CC1311P3 device has several internal system clocks.

The 48MHz SCLK_HF is used as the main system (MCU and peripherals) clock. This can be driven by the internal 48MHz RC Oscillator (RCOSC_HF) or an external 48MHz crystal (XOSC_HF). Radio operation requires an external 48MHz crystal.

SCLK_LF is the 32.768kHz internal low-frequency system clock. It can be used for the RTC and to synchronize the radio timer before or after Standby power mode. SCLK_LF can be driven by the internal 32.8kHz RC Oscillator (RCOSC_LF), a 32.768kHz watch-type crystal, or a clock input on any digital IO.

When using a crystal or the internal RC oscillator, the device can output the 32kHz SCLK_LF signal to other devices, thereby reducing the overall system cost.

8.14 Network Processor

Depending on the product configuration, the CC1311P3 device can function as a wireless network processor (WNP - a device running the wireless protocol stack with the application running on a separate host MCU), or as a system-on-chip (SoC) with the application and protocol stack running on the system CPU inside the device.

In the first case, the external host MCU communicates with the device using SPI or UART. In the second case, the application must be written according to the application framework supplied with the wireless protocol stack.

9 Application, Implementation, and Layout

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

For general design guidelines and hardware configuration guidelines, refer to [CC13xx/CC26xx Hardware Configuration and PCB Design Considerations Application Note](#).

For optimum RF performance, especially when using the high-power PA, it is important to accurately follow the reference design with respect to component values and layout. Failure to do so may lead to reduced RF performance due to balun mismatch. The amplitude- and phase balance through the balun must be <1 dB and <6 degrees, respectively.

PCB stack-up is also critical for proper operation. The CC1311P3 EVMs and characterization boards use a finished thickness between the top layer (RF signals) and layer 2 (ground plane) of 175µm. It is very important to use the same substrate thickness, or slightly thicker, in an end product implementing the CC1311P3 device.

9.1 Reference Designs

The following reference designs should be followed closely when implementing designs using the CC1311P3 device.

Special attention must be paid to RF component placement, decoupling capacitors and DCDC regulator components, as well as ground connections for all of these.

[CC1311-P3EM-7XD7793-PA915 Design Files](#)

The CC1311P3EM-XD7793-PA915 reference design provides schematic, layout and production files for the characterization board used for deriving the performance number found in this document. This reference design is intended for operation in the 868MHz and 915MHz bands.

[LP-CC1311P3 Design Files](#)

The CC1311P3 LaunchPad Design Files contain detailed schematics and layouts to build application specific boards using the CC1311P3 device. This LaunchPad is intended for operation in the 868MHz and 915MHz bands.

[Sub-1GHz and 2.4GHz Antenna Kit for LaunchPad™ Development Kit and SensorTag](#)

The antenna kit allows real-life testing to identify the optimal antenna for your application. The antenna kit includes 16 antennas for frequencies from 169MHz to 2.4GHz, including:

- PCB antennas
- Helical antennas
- Chip antennas
- Dual-band antennas for 868MHz and 915MHz combined with 2.4GHz

The antenna kit includes a JSC cable to connect to the Wireless MCU LaunchPad Development Kits and SensorTags.

10 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed as follows.

10.1 Device Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to all part numbers and/or date-code. Each device has one of three prefixes/identifications: X, P, or null (no prefix) (for example, XCC1311P3 is in preview; therefore, an X prefix/identification is assigned).

Device development evolutionary flow:

- X** Experimental device that is not necessarily representative of the final device's electrical specifications and may not use production assembly flow.
- P** Prototype device that is not necessarily the final silicon die and may not necessarily meet final electrical specifications.
- null** Production version of the silicon die that is fully qualified.

Support tool development evolutionary flow:

- TMDX** Development-support product that has not yet completed Texas Instruments internal qualification testing.
- TMDS** Fully-qualified development-support product.

X and P devices and TMDX development-support tools are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

Production devices and TMDS development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (X or P) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the package type (for example, RGZ).

For orderable part numbers of CC1311P3 devices in the RGZ (7mm x 7mm) package type, see the *Package Option Addendum* of this document, the Device Information in [Section 3](#), the TI website (www.ti.com), or contact your TI sales representative.

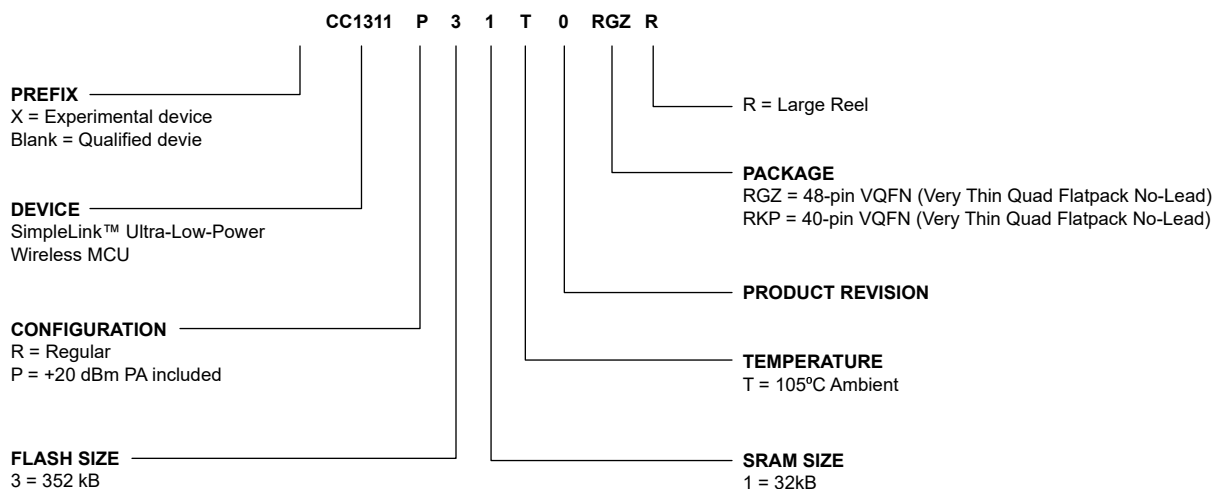


Figure 10-1. Device Nomenclature

10.2 Tools and Software

The CC1311P3 device is supported by a variety of software and hardware development tools.

Development Kit

Software

SimpleLink™ CC13XX- CC26XX SDK

The SimpleLink CC13xx and CC26xx Software Development Kit (SDK) provides a complete package for the development of wireless applications on the CC13XX / CC26XX family of devices. The SDK includes a comprehensive software package for the CC1311P3 device, including the following protocol stacks:

- Bluetooth Low Energy 4 and 5.2
- Thread (based on OpenThread)
- Zigbee 3.0
- Wi-SUN®
- TI 15.4-Stack - an IEEE 802.15.4-based star networking solution for Sub-1GHz and 2.4 GHz
- Proprietary RF - a large set of building blocks for building proprietary RF software
- Multiprotocol support - concurrent operation between stacks using the Dynamic Multiprotocol Manager (DMM)

The SimpleLink CC13XX-CC26XX SDK is part of TI's SimpleLink MCU platform, offering a single development environment that delivers flexible hardware, software and tool options for customers developing wired and wireless applications. For more information about the SimpleLink MCU Platform, visit <http://www.ti.com/simplelink>.

Development Tools

Code Composer Studio™ Integrated Development Environment (IDE)

Code Composer Studio is an integrated development environment (IDE) that supports TI's Microcontroller and Embedded Processors portfolio. Code Composer Studio comprises a suite of tools used to develop and debug embedded applications. It includes an optimizing C/C++ compiler, source code editor, project build environment, debugger, profiler, and many other features. The intuitive IDE provides a single user interface taking you through each step of the application development flow. Familiar tools and interfaces allow users to get started faster than ever before. Code Composer Studio combines the advantages of the Eclipse® software framework with advanced embedded debug capabilities from TI resulting in a compelling feature-rich development environment for embedded developers.

CCS has support for all SimpleLink Wireless MCUs and includes support for EnergyTrace™ software (application energy usage profiling). A real-time object viewer plugin is available for TI-RTOS, part of the SimpleLink SDK.

Code Composer Studio is provided free of charge when used in conjunction with the XDS debuggers included on a LaunchPad Development Kit.

Code Composer Studio™ Cloud IDE

Code Composer Studio (CCS) Cloud is a web-based IDE that allows you to create, edit and build CCS and Energia™ projects. After you have successfully built your project, you can download and run on your connected LaunchPad. Basic debugging, including features like setting breakpoints and viewing variable values is now supported with CCS Cloud.

IAR Embedded Workbench® for Arm®

IAR Embedded Workbench® is a set of development tools for building and debugging embedded system applications using assembler, C and C++. It provides a completely integrated development environment that includes a project manager, editor, and build tools. IAR has support for all SimpleLink Wireless MCUs. It offers broad debugger support, including XDS110, IAR I-jet™ and Segger J-Link™. A real-time object viewer plugin is available for TI-RTOS, part of the SimpleLink SDK. IAR is also supported out-of-the-box on most software examples provided as part of the SimpleLink SDK.

A 30-day evaluation or a 32 KB size-limited version is available through iar.com.

SmartRF™ Studio

SmartRF™ Studio is a Windows® application that can be used to evaluate and configure SimpleLink Wireless MCUs from Texas Instruments. The application will help designers of RF systems to easily evaluate the radio at an early stage in the design process. It is especially useful for generation of configuration register values and for practical testing and debugging of the RF system. SmartRF Studio can be used either as a standalone application or together with applicable evaluation boards or debug probes for the RF device. Features of the SmartRF Studio include:

- Link tests - send and receive packets between nodes
- Antenna and radiation tests - set the radio in continuous wave TX and RX states
- Export radio configuration code for use with the TI SimpleLink SDK RF driver
- Custom GPIO configuration for signaling and control of external switches

CCS UniFlash

CCS UniFlash is a standalone tool used to program on-chip flash memory on TI MCUs. UniFlash has a GUI, command line, and scripting interface. CCS UniFlash is available free of charge.

10.2.1 SimpleLink™ Microcontroller Platform

The SimpleLink microcontroller platform sets a new standard for developers with the broadest portfolio of wired and wireless Arm® MCUs (System-on-Chip) in a single software development environment. Delivering flexible hardware, software and tool options for your IoT applications. Invest once in the SimpleLink software development kit and use throughout your entire portfolio. Learn more on ti.com/simplelink.

10.3 Documentation Support

To receive notification of documentation updates on data sheets, errata, application notes and similar, navigate to the device product folder on ti.com/product/CC1311P3. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

The current documentation that describes the MCU, related peripherals, and other technical collateral is listed as follows.

TI Resource Explorer

TI Resource Explorer

Software examples, libraries, executables, and documentation are available for your device and development board.

Errata

CC1311P3 Silicon Errata

The silicon errata describes the known exceptions to the functional specifications for each silicon revision of the device and description on how to recognize a device revision.

Application Notes

All application notes for the CC1311P3 device are found on the device product folder at: ti.com/product/CC1311P3/#tech-docs.

Technical Reference Manual (TRM)

CC13x1x, CC26x1x SimpleLink™ Wireless MCU TRM

The TRM provides a detailed description of all modules and peripherals available in the device family.

10.4 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

10.5 Trademarks

SimpleLink™, Code Composer Studio™, EnergyTrace™, and TI E2E™ are trademarks of Texas Instruments. I-jet™ is a trademark of IAR Systems AB.

J-Link™ is a trademark of SEGGER Microcontroller Systeme GmbH.

Arm® and Cortex® are registered trademarks of Arm Limited (or its subsidiaries) in the US and/or elsewhere.

CoreMark® is a registered trademark of Embedded Microprocessor Benchmark Consortium Corporation.

Arm Thumb® is a registered trademark of Arm Limited (or its subsidiaries).

Wi-SUN® is a registered trademark of Wi-SUN Alliance Inc.

Eclipse® is a registered trademark of Eclipse Foundation.

IAR Embedded Workbench® is a registered trademark of IAR Systems AB.

Windows® is a registered trademark of Microsoft Corporation.

All trademarks are the property of their respective owners.

10.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.7 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

11 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from March 1, 2022 to April 1, 2025 (from Revision * (March 2022) to Revision A (April 2025))

	Page
• Updated the document per the latest Texas Instruments data sheet standards.....	2
• Updated Device Comparison	5
• Added RKP data.....	9
• Split Rail functionality added to Absolute Maximum Ratings table.....	9
• Split Rail functionality added to the Recommended Operating Conditions table.....	9
• Clarified that current consumption is measured with VDDS=VDDS2=VDDS3.....	10
• Added Voltage Supply Domains	43

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CC1311P31T0RGZR	Active	Production	VQFN (RGZ) 48	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 105	CC1311 P31
CC1311P31T0RGZR.A	Active	Production	VQFN (RGZ) 48	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 105	CC1311 P31
CC1311P31T0RGZR.B	Active	Production	VQFN (RGZ) 48	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 105	CC1311 P31

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

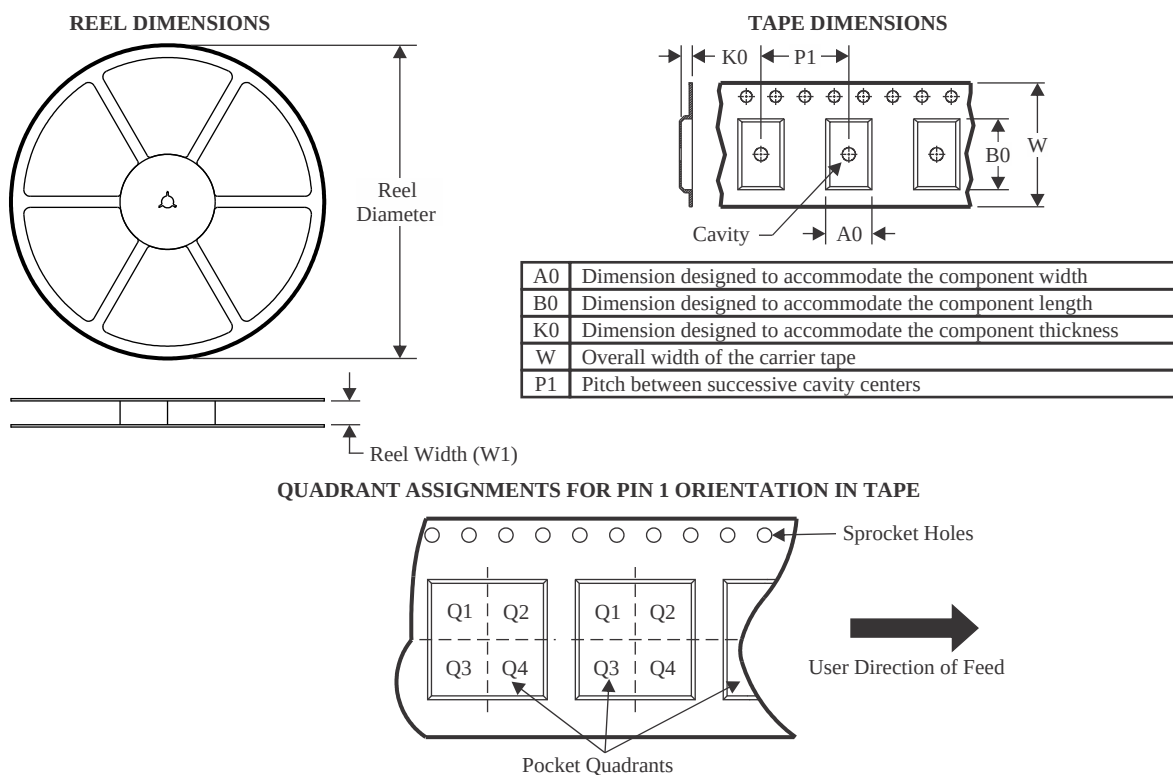
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

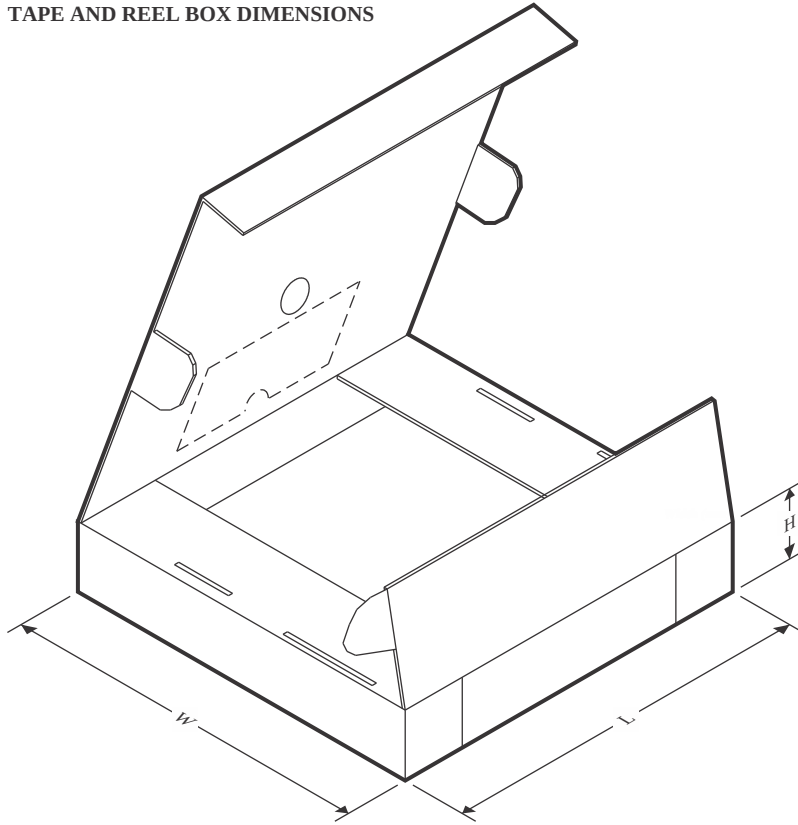
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CC1311P31T0RGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.1	12.0	16.0	Q2
CC1311P31T0RGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.1	12.0	16.0	Q2
CC1311P31T0RGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.1	12.0	16.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CC1311P31T0RGZR	VQFN	RGZ	48	2500	336.6	336.6	31.8
CC1311P31T0RGZR	VQFN	RGZ	48	2500	367.0	367.0	35.0
CC1311P31T0RGZR	VQFN	RGZ	48	2500	360.0	360.0	36.0

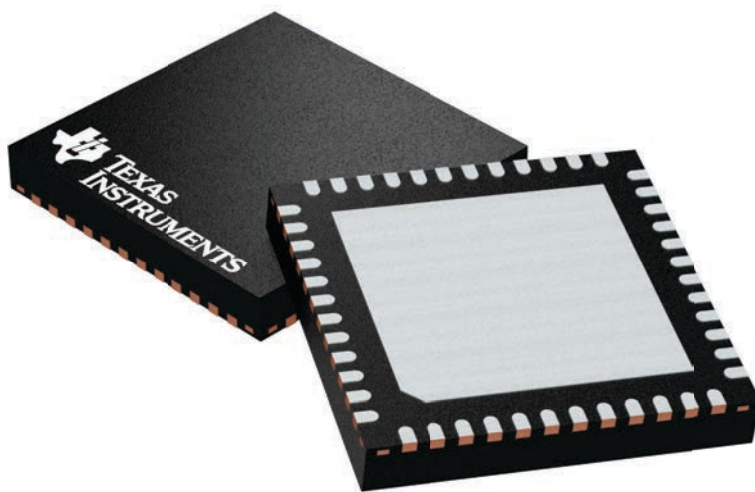
GENERIC PACKAGE VIEW

RGZ 48

VQFN - 1 mm max height

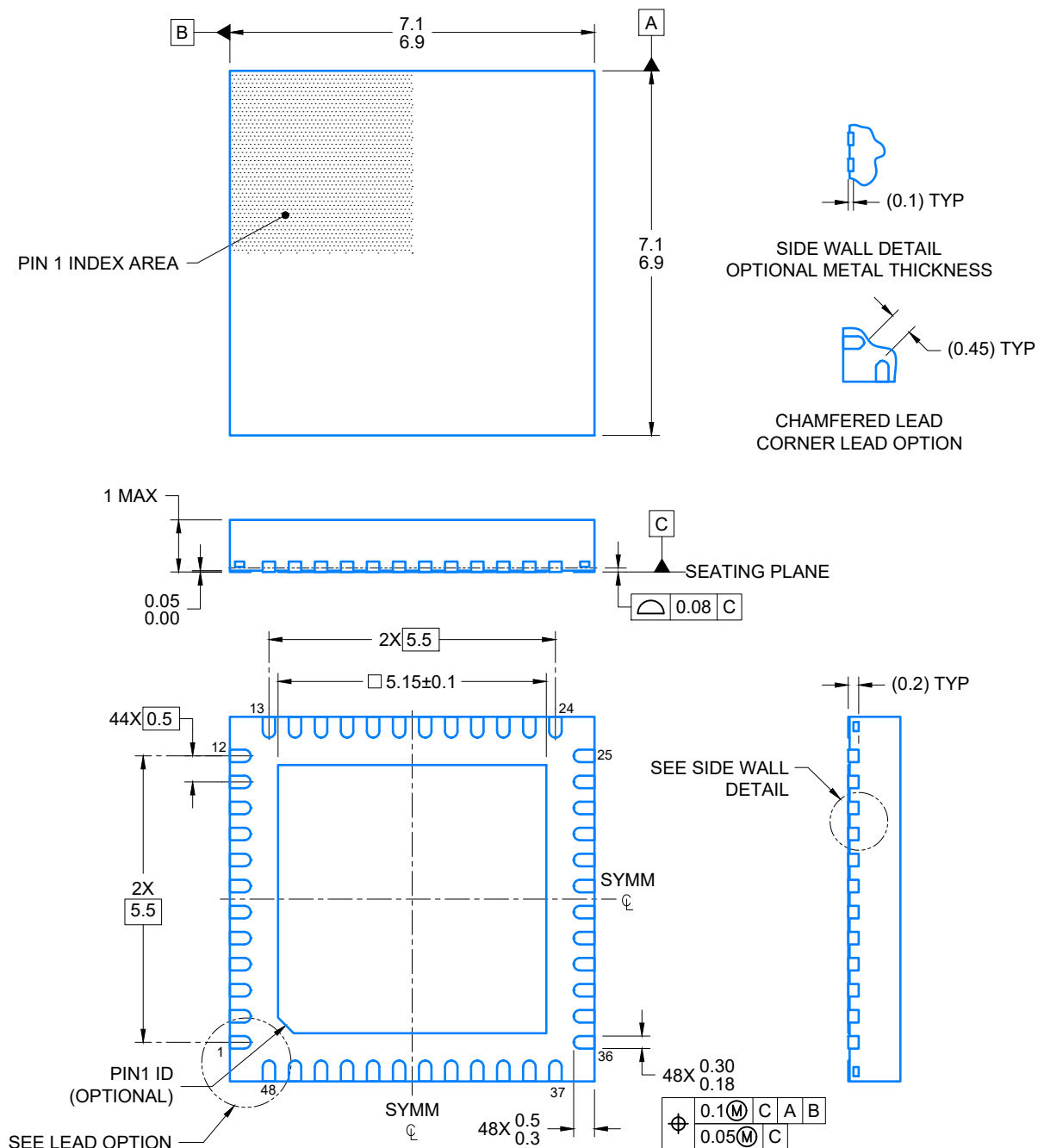
7 x 7, 0.5 mm pitch

PLASTIC QUADFLAT PACK- NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

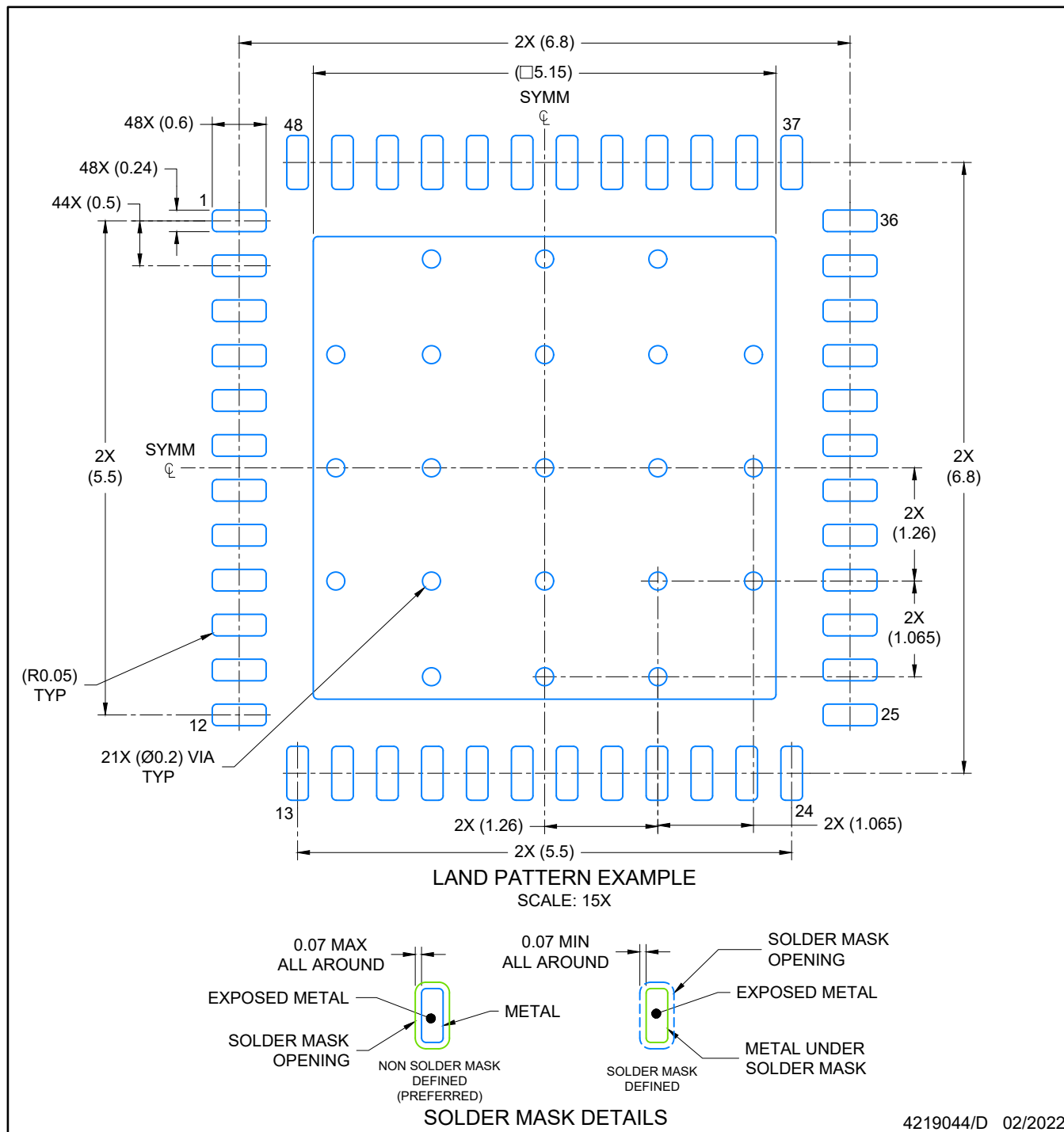
4224671/A



4219044/D 02/2022

NOTES:

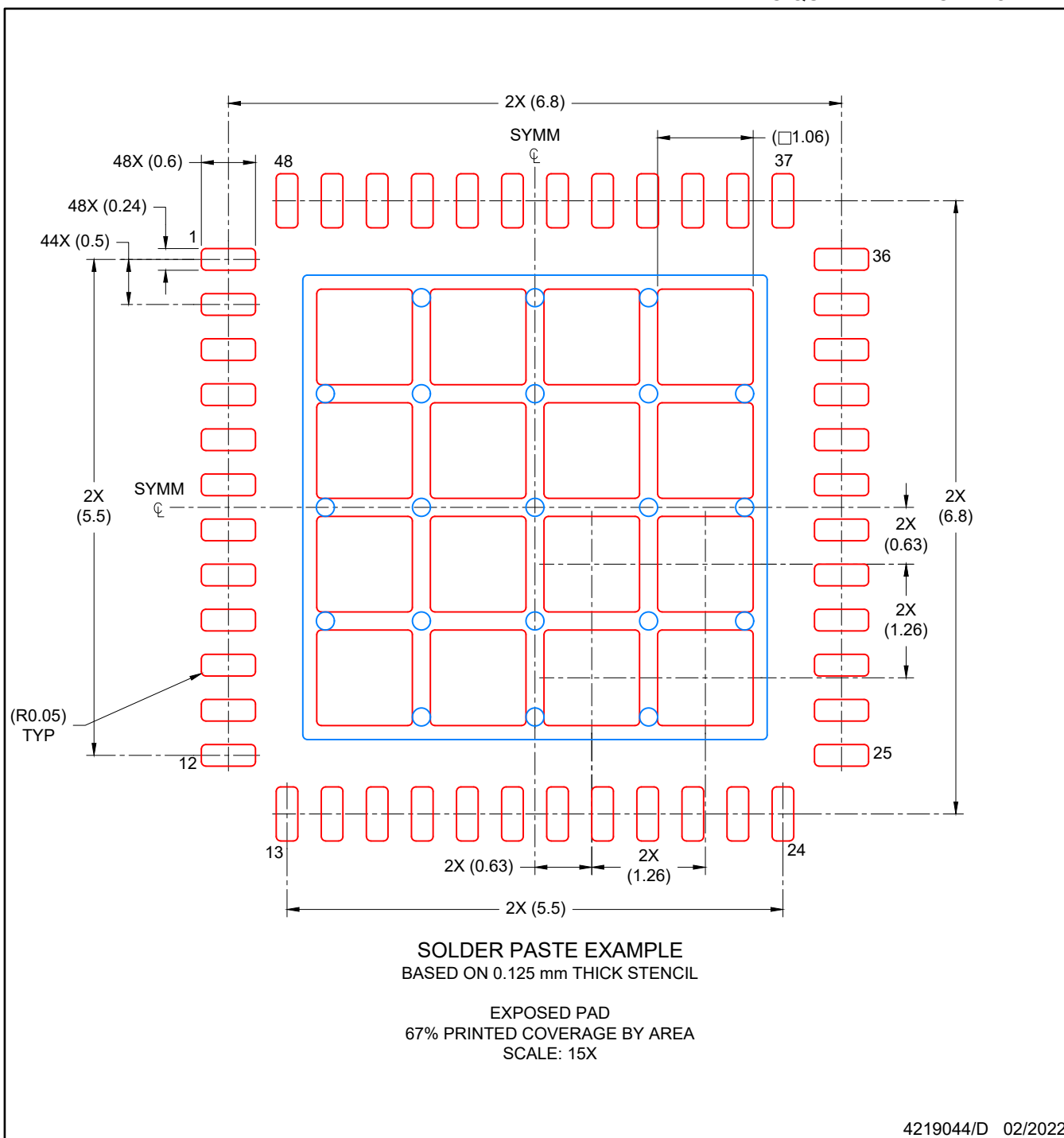
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



4219044/D 02/2022

NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#), [TI's General Quality Guidelines](#), or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2026, Texas Instruments Incorporated

Last updated 10/2025